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#### LMP90077, LMP90078, LMP90079, LMP90080

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LMP9007x/LMP90080 传感器 AFE 系统:具有真正连续后台校准功能的多 通道低功耗 16 位传感器 AFE

#### 1 特性

- 16 位低功耗 Σ-Δ 模数转换器 (ADC) •
- 所有增益上的真连续背景校准
- 使用期望值编程进行适当的系统校准 .
- 低噪声可编程增益 (1x 128x)
- 连续后台开路/短路和范围外传感器诊断
- 单周期稳定的 8 个输出数据速率 (ODR)
- 源自 100µA 至 1000 µA 的 2 个已匹配激励电流 (LMP90080/LMP90078)
- 4个差分输入/7个单端输入 (LMP90080/LMP90079)
- 2个差分输入/4个单端输入 (LMP90078/LMP90077)
- 7个通用输入/输出引脚
- 用于实现低偏移的斩波稳定缓冲器
- 支持循环冗余码校验 (CRC) 数据链接误差检测的 SPI 4/3 线制接口
- ODR ≤ 13.42SPS 时的 50Hz 至 60Hz 线路扰动抑 ٠ 制
- 每通道独立增益和 ODR 选择
- 由 WEBENCH<sup>®</sup>传感器 AFE 设计工具提供支持
- 自动通道排序器
- 主要技术规范
  - 有效位数 (ENOB)/NFR: 高达 16/16 位
  - 偏移误差(典型值): 8.4nV
  - 增益误差(典型值): 7ppm
  - 总体噪声: < 10µV-rms</li>

- 积分非线性(INL 最大值): ±1 最低有效位 (LSB)
- 输出数据速率 (ODR): 1.6775 至 214.65SPS
- 模拟电压 VA: 2.85V 至 5.5V
- 工作温度范围: -40°C 至 125°C
- 封装: 28 引脚带外露垫封装
- 2 应用
- 温度和压力发送器 •
- 应变仪接口
- 工业过程控制

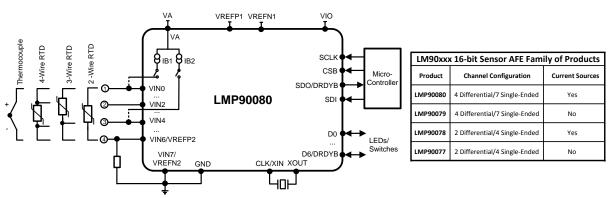
# 3 说明

LLMP9007x 和 LMP90080 是高度集成的多通道低功 耗 16 位传感器模拟前端 (AFE)。此器件特有一个精密 16 位三角积分模数转换器 (ADC),此转换器具有一个 低噪声可编程增益放大器和一个完全差分高阻抗模拟输 入复用器。一个真连续后台校准特性可在所有增益和输 出数据速率上实现校准而又不会中断信号路径。后台校 准特性在温度和时间范围内从根本上消除了增益和偏移 误差,从而在不损失速度和功耗的情况下提供测量精 度。

器件信息(1)

器件型号	封装	封装尺寸(标称值)
LMP90077		
LMP90078		0.70mm v 4.40mm
LMP90079	HTSSOP (28)	9.70mm x 4.40mm
LMP90080		

(1) 如需了解所有可用封装,请参见数据表末尾的可订购产品附 录。



# 典型传感器应用



### LMP90077, LMP90078, LMP90079, LMP90080

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# 4 修订历史记录

Cł	nanges from Revision G (January 2015) to Revision H	Page
•	Changed Buffer Enable/Disable.	48
•	Changed BUF_EN = 1 to 0.	53

### Changes from Revision F (March 2013) to Revision G

•	已添加 引脚配置和功能部分,ESD 额定值表,特性 描述 部分,器件功能模式,应用和实施部分,电源相关建议部 分,布局部分,器件和文档支持部分以及机械、封装和可订购信息部分	1
•	Added footnote to INL, GE, and Crosstalk specifications.	6
•	Changed t <sub>DOD1</sub> specification.	. 11
•	Deleted CH_STS and ADC_DOUTM from Compute the CRC sentence	. 38
•	Added sentence to the end of the RESET and RESTART section.	. 39
Cł	nanges from Revision E (March 2013) to Revision F	age

•	Changed layout of National Data Sheet to TI format	52
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### 5 说明 (续)

LMP9007x 和 LMP90080 的另一项功能是连续后台传感器诊断,无需用户介入即可检测开路和短路状态以及超出 范围的信号,能够强化系统稳定性。

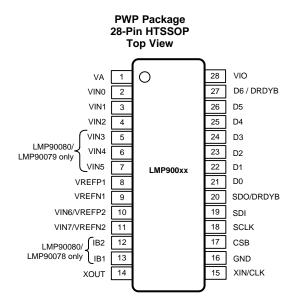
两组独立外部基准引脚可实现多比率测量。此外,LMP90080/LMP90078 还提供两个匹配的可编程电流源,用于为 阻性温度检测器和桥式传感器等外部传感器供电。此外,两种器件还提供了 7 个通用输入/输出 (GPIO) 引脚与外部 发光二极管 (LED) 和开关进行对接,以简化对于绝缘栅的控制。

凭借这一系列 功能, LMP90080/LMP90079/LMP90078/LMP90077 完整模拟前端能够应用于精密的低功耗传感器 应用 例如温度计、压力计、应力计和工业过程控制。LMP90080/LMP90079/LMP90078/LMP90077 采用 28 引脚 外露焊盘封装,均可在 -40℃ 至 +125℃ 的扩展温度范围内运行。

### 6 Device Comparison Table

LM90xxx 16-BIT SENOR AFE FAMILY OF PRODUCTS				
DEVICE NUMBER	CHANNEL CONFIGURATION	CURRENT SOURCES		
LMP90080	4 Differential/7 Single Ended			
LMP90079	4 Differential/7 Single-Ended	Yee		
LMP90078	2 Differential/4 Cingle Ended	Yes		
LMP90077	2 Differential/4 Single-Ended			

# 7 Pin Configuration and Functions



**Pin Functions** 

PIN						
NAME	LMP90080 PIN NO.	LMP90079 PIN NO.	LMP90078 PIN NO.	LMP90077 PIN NO.	TYPE	FUNCTION
VA	1	1	1	1	Analog Supply	Analog power supply pin
VIN0	2	2	2	2		
VIN1	3	3	3	3	Analog Input	Analog input pins
VIN2	4	4	4	4		
VIN3	5	5	—	_		
VIN4	6	6	—	_	Analog Input	Analog input pins
VIN5	7	7	_			
VIN3	_	—	5	5		
VIN4	_	—	6	6	No Connect	No connect: must be left unconnected
VIN5	_	—	7	7		
VREFP1	8	8	8	8	Analog Input	Positive reference input
VREFN1	9	9	9	9	Analog Input	Negative reference input
VIN6 / VREFP2	10	10	10	10	Analog Input	Analog input pin or VREFP2 input
VIN7 / VREFN2	11	11	11	11	Analog Input	Analog input pin or VREFN2 input
IB2	12	_	12			Excitation current sources for
IB1	13	_	13		Analog output	external RTDs
IB2	_	12		12		No connect: must be left
IB1	_	13		13	No Connect	unconnected
XOUT	14	14	14	14	Analog output	External crystal oscillator connection
XIN / CLK	15	15	15	15	Analog input	External crystal oscillator connection or external clock input
GND	16	16	16	16	Ground	Power supply ground
CSB	17	17	17	17	Digital Input	Chip select bar
SCLK	18	18	18	18	Digital Input	Serial clock



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#### **Pin Functions (continued)**

		PIN				
NAME	LMP90080 PIN NO.	LMP90079 PIN NO.	LMP90078 PIN NO.	LMP90077 PIN NO.	TYPE	FUNCTION
SDI	19	19	19	19	Digital Input	Serial data input
SDO / DRDYB	20	20	20	20	Digital Output	Serial data output and data ready bar
D0	21	21	21	21		
D1	22	22	22	22		
D2	23	23	23	23	Distict	General purpose input/output
D3	24	24	24	24	Digital IO	(GPIO) pins
D4	25	25	25	25		
D5	26	26	26	26		
D6 / DRDYB	27	27	27	27	Digital IO	General purpose input/output pin or data ready bar
VIO	28	28	28	28	Digital Supply	Digital input/output supply pin
Thermal Pad	—	—	—	—	_	Leave the thermal pad floating

### 8 Specifications

### 8.1 Absolute Maximum Ratings

See (1)(2)(3)(4).

	MIN	MAX	UNIT
Analog Supply Voltage, VA	-0.3	6.0	
Digital I/O Supply Voltage, VIO	-0.3	6.0	
Reference Voltage, VREF	-0.3	VA+0.3	v
Voltage on Any Analog Input Pin to GND <sup>(5)</sup>	-0.3	VA+0.3	V
Voltage on Any Digital Input PIN to GND <sup>(5)</sup>	-0.3	VIO+0.3	
Voltage on SDO <sup>(5)</sup>	-0.3	VIO+0.3	
Input Current at Any Pin <sup>(5)</sup>		5	
Output Current Source or Sink by SDO		5	mA
Total Package Input and Output Current		20	
Junction Temperature (T <sub>JMAX</sub> )		150	°C
Storage Temperature (T <sub>stg</sub> )	-65	150	°C

(1) All voltages are measured with respect to GND, unless otherwise specified

(2) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(3) For soldering specifications see product folder at http://www.ti.com and http://www.ti.com/lit/SNOA549
 (4) If Military/Aerospace specified devices are required, contact the Texas Instruments Sales Office/ Distributors for availability and specifications.

(5) When the input voltage (VIN) exceeds the power supply (VIN < GND or VIN > VA), the current at that pin must be limited to 5mA and VIN has to be within the Absolute Maximum Rating for that pin. The 20 mA package input current rating limits the number of pins that can safely exceed the power supplies with current flow to four pins.

### 8.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub> Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2500		
	Charged-device model (CDM), per JEDEC specification JESD22-C101 $^{(2)}$	±1250	V	
		Machine models (MM)	±200	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

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### 8.3 Recommended Operating Conditions

	MIN	MAX	UNIT
Analog Supply Voltage, VA	2.85	5.5	
Digital I/O Supply Voltage, VIO	2.7	5.5	v
Full Scale Input Range, VIN		±VREF / PGA	V
Reference Voltage, VREF	0.5	VA	
Temperature Range for Electrical Characteristics	-40	125	°C
Operating Temperature Range	-40	125	
Junction to Ambient Thermal Resistance (R <sub>0JA</sub> ) <sup>(1)</sup>		41	°C/W

(1) The maximum power dissipation is a function of  $T_{J(MAX)}$  AND  $R_{\theta JA}$ . The maximum allowable power dissipation at any ambient temperature is  $P_D = (T_{J(MAX)} - T_A) / R_{\theta JA}$ .

### 8.4 Thermal Information

	THERMAL METRIC <sup>(1)</sup>	LMP900xx	
		HTSSOP (28 PINS)	) UNIT
I	R <sub>0JA</sub> Junction-to-ambient thermal resistance	41	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

### 8.5 Electrical Characteristics

Unless otherwise noted, the key for the condition is (VA = VIO = VREF) / ODR (SPS) / buffer / calibration / gain . The typical values apply for  $T_A = +25^{\circ}C$ .

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
n	Resolution			16		Bits
ENOB /	Effective Number of	3V / all / ON / OFF / all. Shorted input.		See Table 1		Bits
NFR	Bits and Noise Free Resolution	5V / all / ON / OFF / all. Shorted input.		See Table 3		Bits
ODR	Output Data Rates		1.6675	See Table 1	214.6	SPS
	Gain	FGA × PGA	1	See Table 3	128	
	Integral Non-	3V / 214.65 / ON / ON / 1	-1	± 0.5	+1	LSB
INL	Linearity <sup>(1)</sup>	3V & 5V / 214.65 / ON / ON / 16		± 1		LSB
	<b>T</b> ( 181 )	3V / all / ON / ON / all. Shorted input.		See Table 2		μV
	Total Noise	5V / all / ON / OFF / all. Shorted input.		See Table 4		μV
		3V & 5V / all / ON or OFF / ON / all		Below Noise Floor (rms)		μV
		3V / 214.65 / ON / ON / 1		1.22	9.52	μV
OE	Offset Error	3V / 214.65 / ON / ON / 128		0.00838	0.70	μV
		5V / 214.65 / ON / ON / 1		1.79	8.25	μV
		5V / 214.65 / ON / ON / 128		0.0112	0.63	μV
		3V & 5V / 214.65 / ON or OFF/OFF/1-8		100		nV/°C
		3V & 5V / 214.65 / ON / ON / 1-8		3		nV/°C
	Offset Drift Over	3V & 5V / 214.65 / ON / OFF / 16		25		nV/°C
	Temp <sup>(1)</sup>	3V & 5V / 214.65 / ON / ON / 16		0.4		nV/°C
		3V & 5V / 214.65 / ON / OFF / 128		6		nV/°C
		3V & 5V / 214.65 / ON / ON / 128		0.125		nV/°C
	Offset Drift over	5V / 214.65 / ON / OFF / 1, T <sub>A</sub> = 150°C		2360		nV/1000 hours
	Time <sup>(1)</sup>	5V / 214.65 / ON / ON / 1, T <sub>A</sub> = 150°C		100		nV/1000 hours
		$3V \& 5V / 214.65 / ON / ON / 1, T_{MIN} \le T_A \le T_{MAX}$	-80		80	ppm
		3V & 5V / 214.65 / ON / ON / 1		7		ppm
GE	Gain Error <sup>(1)</sup>	3V & 5V / 13.42 / ON / ON / 16		50		ppm
		3V & 5V / 13.42 / ON / ON / 64		50		ppm
		3V & 5V / 13.42 / ON / ON / 128		100		ppm
	Gain Drift over Temp <sup>(1)</sup>	3V & 5V / 214.65 / ON / ON / all		0.5		ppm/°C

(1) This parameter is specified by design and/or characterization and is not tested in production.



### **Electrical Characteristics (continued)**

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Gain Drift over Time <sup>(1)</sup>	5V / 214.65 / ON / OFF / 1, T <sub>A</sub> = 150°C		5.9		ppm/1000 hours
	Gain Dritt over Time	5V / 214.65 / ON / ON / 1, T <sub>A</sub> = 150°C		1.6		ppm/1000 hours
CONVER	TER CHARACTERISTICS		•			
		DC, $3V / 214.65 / ON / ON / 1$ , T <sub>MIN</sub> $\leq T_A \leq T_{MAX}$	70			dB
CMRR		DC, 3V / 214.65 / ON / ON / 1		117		dB
	Input Common Mode Rejection Ratio	DC, 5V / 214.65 / OFF / OFF / 1, $T_{MIN} \le T_A \le T_{MAX}$	90			dB
		DC, 5V / 214.65 / OFF / OFF / 1		120		dB
		50/60 Hz, 5V / 214.65 / OFF / OFF / 1		117		dB
	Reference Common Mode Rejection	VREF = 2.5V		101		dB
PSRR	Power Supply	DC, 3V / 214.65 / ON / ON / 1	75	115		dB
PSKK	Rejection Ratio	DC, 5V / 214.65 / ON / ON / 1		112		dB
NMRR	Normal Mode Rejection Ratio <sup>(1)</sup>	47 Hz to 63 Hz, 5V / 13.42 / OFF / OFF / 1 $T_{MIN} \leq T_{A} \leq T_{MAX}$	95			dB
		3V / 214.65 / OFF / OFF / 1, $T_{MIN} \le T_A \le T_{MAX}$	95			dB
	Cross-talk <sup>(1)</sup>	3V / 214.65 / OFF / OFF / 1		136		dB
	CIUSS-IAIK V	5V / 214.65 / OFF / OFF / 1, $T_{MIN} \le T_A \le T_{MAX}$	95			dB
		5V / 214.65 / OFF / OFF / 1		143		dB
POWER	SUPPLY CHARACTERIST	TICS				
VA	Analog Supply Voltage		2.85	3.0	5.5	V
VIO	Digital Supply Voltage		2.7	3.3	5.5	V

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### **Electrical Characteristics (continued)**

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		3V / 13.42 / OFF / OFF / 1, ext. CLK		400		μA
		3V / 13.42 / OFF / OFF / 1, ext. CLK,			500	μA
		$T_{MIN} \le T_A \le T_{MAX}$			000	μ. (
		5V / 13.42 / OFF / OFF / 1, ext. CLK		464		μΑ
		5V / 13.42 / OFF / OFF / 1, ext. CLK,			555	μA
		$T_{MIN} \le T_A \le T_{MAX}$				
		3V / 13.42 / ON / OFF / 64, ext. CLK		600		μA
		3V / 13.42 / ON / OFF / 64, ext. CLK,			700	μA
		$T_{MIN} \le T_A \le T_{MAX}$		000		
		5V / 13.42 / ON / OFF / 64, ext. CLK		690		μA
	5V / 13.42 / ON / OFF / 64, ext. CLK, T <sub>MIN</sub> $\leq$ T <sub>A</sub> $\leq$ T <sub>MAX</sub>			800	μΑ	
		3V / 214.65 / ON / OFF / 64, int. CLK		1547		μA
	3V / 214.65 / ON / OFF / 64, int. CLK,		1047		μ/ (	
		$T_{MIN} \le T_A \le T_{MAX}$			1700	μA
		5V / 214.65 / ON / OFF / 64, int. CLK		1760		μA
VA	Analog Supply Current	5V / 214.65 / ON / OFF / 64, int. CLK,			005-	
		$T_{MIN} \le T_A \le T_{MAX}$			2000	μA
		3V / 214.65 / OFF / OFF / 1, int. CLK		826		μA
		3V / 214.65 / OFF / OFF / 1, int. CLK,			1000	
		$T_{MIN} \le T_A \le T_{MAX}$			1000	μA
		5V / 214.65 / OFF / OFF / 1, int. CLK		941		μA
		5V / 214.65 / OFF / OFF / 1, int. CLK, T <sub>MIN</sub> $\leq$ T <sub>A</sub> $\leq$ T <sub>MAX</sub>			1100	μA
		Standby, 3V , int. CLK		3	10	μA
		Standby, 3V , ext. CLK		257		μA
		Standby, 5V, int. CLK		5	15	μA
		Standby, 3V, ext. CLK		300		μA
		Power-down, 3V, int/ext CLK		2.6		μA
		Power-down, 3V, int/ext CLK, $T_{MIN} \le T_A \le T_{MAX}$			5	μA
		Power-down, 5V, int/ext CLK		4.6		μA
		Power-down, 5V, int/ext CLK, $T_{MIN} \le T_A \le T_{MAX}$			9	μA
REFEREN						,
/REFP	Positive Reference		VREFN + 0.5		VA	V
	Nagativa Bafaranaa		CND		VREFP -	V
/REFN	Negative Reference		GND		0.5	v
<b>VREF</b>	Differential Reference	VREF = VREFP - VREFN	0.5		VA	V
ZREF	Reference Impedance	3V / 13.42 / OFF / OFF / 1		10		MΩ
REF	Reference Input	3V / 13.42 / ON or OFF /ON or OFF/all		±2		μΑ
CREFP	Capacitance of the Positive Reference	gain = 1 <sup>(1)</sup>		6		pF
CREFN	Capacitance of the Negative Reference	gain = 1 <sup>(1)</sup>		6		pF
LREF	Reference Leakage Current	Power-down		1		nA
ANALOG	INPUT				I	
		Gain = 1-8, buffer ON	GND + 0.1		VA - 0.1	V
/INP	Positive Input	Gain = 16 - 128, buffer ON	GND + 0.4		VA - 1.5	V
	·	Gain = 1-8, buffer OFF	GND		VA	V
		Gain = 1-8, buffer ON	GND + 0.1		VA - 0.1	V
/INN	Negative Input	Gain = 16 - 128, buffer ON	GND + 0.4		VA - 1.5	V
		Gain = 1-8, buffer OFF	GND		VA	V



### **Electrical Characteristics (continued)**

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VIN	Differential Input	VIN = VINP - VINN		±VREF / PGA		
ZIN	Differential Input Impedance	ODR = 13.42 SPS		15.4		MΩ
CINP	Capacitance of the Positive Input	5V / 214.65 / OFF / OFF / 1		4		pF
CINN	Capacitance of the Negative Input	5V / 214.65 / OFF / OFF / 1		4		pF
IIN	Input Leakage Current	3V & 5V / 13.42 / ON / OFF / 1-8		500		pА
IIIN	Input Leakage Current	3V & 5V / 13.42 / ON / OFF / 16 - 128		100		pА
DIGITAL I	NPUT CHARACTERISTIC	CS at VA = VIO = VREF = 3.0 V				
VIH	Logical "1" Input Voltage		0.7 x VIO			V
VIL	Logical "0" Input Voltage				0.3 x VIO	V
IIL	Digital Input Leakage Current		-10		+10	μA
VHYST	Digital Input Hysteresis			0.1 x VIO		V
DIGITAL C	OUTPUT CHARACTERIS	TICS at VA = VIO = VREF = 3.0 V				
VOH	Logical "1" Output Voltage	Source 300 µA	2.6			V
VOL	Logical "0" Output Voltage	Sink 300 µA			0.4	V
iozh, Iozl	TRI-STATE Leakage Current		-10		10	μA
COUT	TRI-STATE Capacitance	See <sup>(1)</sup>		5		pF
EXCITATI	ON CURRENT SOURCES	CHARACTERISTICS (LMP90080/LMP90078 ONLY)				
IB1, IB2	Excitation Current Source Output			0, 100, 200, 300, 400, 500, 600, 700, 800, 900, 1000		μΑ
		VA = VREF = 3V		2.5%		
	IB1/IB2 Tolerance	$VA = VREF = 3V, T_{MIN} \le T_A \le T_{MAX}$	-7%		7%	
		VA = VREF = 5V		0.2%		
		$VA = VREF = 5V, T_{MIN} \le T_A \le T_{MAX}$	-3.5%		3.5%	
	IB1/IB2 Output Compliance Range	VA = 3.0V & 5.0V, IB1/IB2 = 100 µA to 1000 µA		VA - 0.8		V
	IB1/IB2 Regulation	VA = 5.0V, IB1/IB2 = 100 µA to 1000 µA		0.07		%/V
IBTC	IB1/IB2 Drift	VA = 3.0V		95		ppm/°C
	וטו/וסב טווונ	VA = 5.0V				ppm/°C

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### **Electrical Characteristics (continued)**

P	ARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 100 µA	0.34%		
		$3V \& 5V / 214.65 / OFF / OFF / 1, \\ IB1/IB2 = 100 \ \mu\text{A}, \ T_{\text{MIN}} \leq T_{\text{A}} \leq T_{\text{MAX}}$		1.53%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 200 μA	0.22%		
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 200 µA, T <sub>MIN</sub> ≤ T <sub>A</sub> ≤ T <sub>MAX</sub>		1%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 300 μA	0.2%		
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 300 µA, T <sub>MIN</sub> ≤ T <sub>A</sub> ≤ T <sub>MAX</sub>		0.85%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 400 μA	0.15%		
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 400 $\mu$ A, T <sub>MIN</sub> $\leq$ T <sub>A</sub> $\leq$ T <sub>MAX</sub>		0.8%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 500 µA	0.14%		
ВМТ	IP1/IP2 Motobing	$ \begin{array}{l} 3V \& 5V \ / \ 214.65 \ / \ OFF \ / \ OFF \ / \ 1, \\ IB1 \ / IB2 = 500 \ \mu A, \ T_{MIN} \leq T_A \leq T_{MAX} \end{array} $		0.7%	
DIVIT	IB1/IB2 Matching	3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 600 µA	0.13%		
		$3V \& 5V / 214.65 / OFF / OFF / 1, \\ IB1/IB2 = 600 \ \mu\text{A}, \ T_{MIN} \leq T_{\text{A}} \leq T_{MAX}$		0.7%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 700 µA	0.075%		
		$\begin{array}{l} 3V \& 5V \ / \ 214.65 \ / \ OFF \ / \ OFF \ / \ 1, \\ IB1 \ / IB2 = 700 \ \mu\text{A}, \ T_{MIN} \le T_{A} \le T_{MAX} \end{array}$		0.65%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 800 µA	0.085%		
		$\begin{array}{l} 3V \& 5V \ / \ 214.65 \ / \ OFF \ / \ OFF \ / \ 1, \\ IB1 \ / IB2 = 800 \ \mu A, \ T_{MIN} \le T_A \le T_{MAX} \end{array}$		0.6%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 900 µA	0.11%		
		$3V \& 5V / 214.65 / OFF / OFF / 1, \\ IB1/IB2 = 900 \ \mu\text{A}, T_{\text{MIN}} \le T_{\text{A}} \le T_{\text{MAX}}$		0.55%	
		3V & 5V / 214.65 / OFF / OFF / 1, IB1/IB2 = 1000 μA	0.11%		
		$3V \& 5V / 214.65 / OFF / OFF / 1, \\ IB1/IB2 = 1000 \ \mu\text{A}, \ T_{\text{MIN}} \leq T_{\text{A}} \leq T_{\text{MAX}}$		0.45%	
BMTC	IB1/IB2 Matching Drfit	VA = 3.0V & 5.0V, IB1/IB2 = 100 µA to 1000 µA	2		ppm/°C
NTERNAL/	EXTERNAL CLK			I	
CLKIN	Internal Clock Frequency		893		kHz
CLKEXT	External Clock Frequency	See <sup>(1)</sup>	1.8 3.5717	7.2	MHz
		Input Low Voltage	0		V
	External Crystal	Input High Voltage	1		V
	Frequency	Frequency	1.8 3.5717	7.2	MHz
		Start-up time	7		ms
SCLK	Serial Clock			10	MHz



#### 8.6 Timing Requirements

Unless otherwise noted,	enacified limite ann	ly for V. – V. –	- 3 V. The typical value	is apply for $T_{\rm c} = 25^{\circ}C_{\rm c}$
	specified infines app	$v_A - v_{0} - $	- 5 v. The typical value	$apply 101 T_A = 20 0$ .

			MIN	NOM	MAX	UNIT
f <sub>SCLK</sub>					10	MHz
t <sub>CH</sub>	SCLK High time	See Figure 1.	0.4 / f <sub>SCLK</sub>			ns
t <sub>CL</sub>	SCLK Low time		0.4 / f <sub>SCLK</sub>			ns

### 8.7 Timing Requirements - CSB Timing

			MIN	NOM	MAX	UNIT
tcssu	t <sub>CSSU</sub> CSB Setup time prior to an SCLK rising edge See Figure 2.		5			ns
t <sub>CSH</sub>	CSB Hold time after the last rising edge of SCLK	See Figure 3.	6			ns

#### 8.8 Timing Requirements - SCLK and SDI Timing

			MIN	NOM	MAX	UNIT
t <sub>CLKR</sub>	SCLK Rise time	See Figure 4.		1.15		ns
t <sub>CLKF</sub>	SCLK Fall time			1.15		ns
t <sub>DISU</sub>	SDI Setup time prior to an SCLK rising edge	See Figure F	5			ns
t <sub>DIH</sub>	SDI Hold time after an SCLK rising edge	- See Figure 5.	6			ns

### 8.9 Timing Requirements - SDO Timing With DOD1

			MIN	NOM	MAX	UNIT
t <sub>DOA</sub>	SDO Access time after an SCLK falling edge				35	ns
t <sub>DOH</sub>	SDO Hold time after an SCLK falling edge	See Figure 6.	5			ns
t <sub>DOD1</sub>	SDO Disable time after the rising edge of CSB	See Figure 7.			27	ns

#### 8.10 Timing Requirements - SDO Timing with DOD2

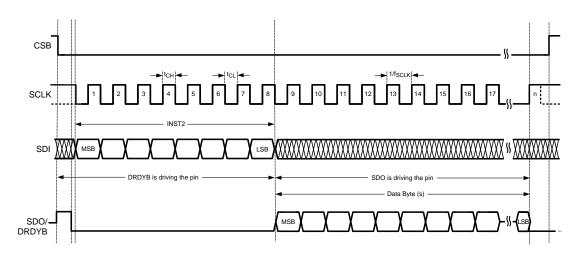
			MIN	NOM	MAX	UNIT
t <sub>DOD2</sub>	SDO Disable time after either edge of SCLK	See Figure 8 and Figure 9.			27	ns

### 8.11 Timing Requirements - SDO and DRDYB Timing

			MIN	NOM	MAX	UNIT
t <sub>DOE</sub>	SDO Enable time from the falling edge of the 8th SCLK	See Figure 10.			35	ns
t <sub>DOR</sub>	SDO Rise time <sup>(1)</sup>	See Figure 11		7		ns
t <sub>DOF</sub>	SDO Fall time <sup>(1)</sup>	See Figure 11.		7		ns
	Data Ready Bar pulse at every	ODR ≤ 13.42 SPS		64		μs
<sup>t</sup> DRDYB	1/ODR second	13.42 < ODR ≤ 214.65 SPS		4		μs

(1) This parameter is specified by design and/or characterization and is not tested in production.







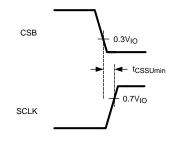


Figure 2. CBS Setup Time

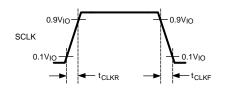


Figure 4. SCLK Rise and Fall Time

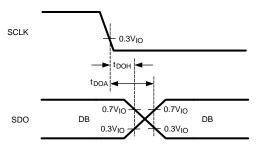


Figure 6. SDO Enable Time

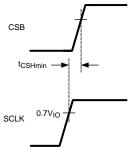


Figure 3. CBS Hold Time

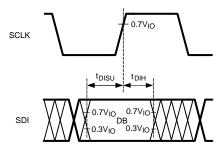


Figure 5. SCLK Setup and Hold Time

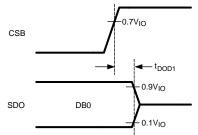
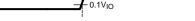
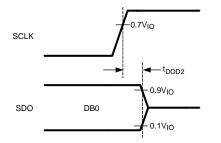


Figure 7. SDO Rise and Fall Time

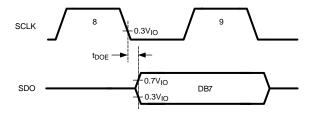




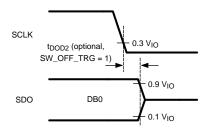
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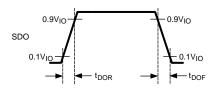




### Figure 10. SDO Enable Time



### Figure 9. SDO Rise and Fall Time



### Figure 11. SDO Rise and Fall Time

Table 1 ENOB	(Noise Free Resolution	) vs Sampling	a Rate and Gain At	$V_{4} = V_{10} = V_{222} = 3V$
		<i>)</i> vo oampini <u>s</u>	g Nate and Gam At	$\mathbf{v}_{A} = \mathbf{v}_{IO} = \mathbf{v}_{REF} = \mathbf{v}_{V}$

	GAIN								
ODR (SPS)	1	2	4	8	16	32	64	128	
1.6775	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15.5)	
3.355	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (14.5)	
6.71	16 (16)	16 (16)	16 (16)	16 (15.5)	16 (16)	16 (16)	16 (15)	16 (14.5)	
13.42	16 (16)	16 (16)	16 (15.5)	16 (15)	16 (16)	16 (15.5)	16 (15)	16 (14)	
26.83125	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15.5)	16 (15)	
53.6625	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15)	16 (14.5)	
107.325	16 (16)	16 (16)	16 (16)	16 (15.5)	16 (16)	16 (15.5)	16 (14.5)	16 (14)	
214.65	16 (16)	16 (16)	16 (15.5)	16 (15)	16 (16)	16 (15)	16 (14.5)	16 (13.5)	

# Table 2. RMS Noise (mV) vs Sampling Rate and Gain At $V_A = V_{IO} = V_{REF} = 3V$

	GAIN OF THE ADC								
ODR (SPS)	1	2	4	8	16	32	64	128	
1.6775	3.08	1.90	1.53	1.27	0.23	0.21	0.15	0.14	
3.355	4.56	2.70	2.21	1.67	0.34	0.27	0.24	0.26	
6.71	6.15	4.10	3.16	2.39	0.51	0.40	0.37	0.35	
13.42	8.60	5.85	4.29	3.64	0.67	0.54	0.51	0.49	
26.83125	3.35	2.24	1.65	1.33	0.33	0.27	0.26	0.25	
53.6625	4.81	3.11	2.37	1.90	0.44	0.39	0.37	0.36	
107.325	6.74	4.51	3.38	2.66	0.63	0.54	0.52	0.49	
214.65	9.52	6.37	4.72	3.79	0.90	0.79	0.72	0.70	

# Table 3. ENOB (Noise Free Resolution) vs Sampling Rate and Gain At $V_A = V_{IO} = V_{REF} = 5V$

CDC				GAIN OF	THE ADC			
SPS	1	2	4	8	16	32	64	128
1.6775	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)
3.355	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15.5)
6.71	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15)
13.42	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15.5)	16 (15)
26.83125	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15.5)
53.6625	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15)
107.325	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15.5)	16 (14.5)
214.65	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (16)	16 (15)	16 (14)

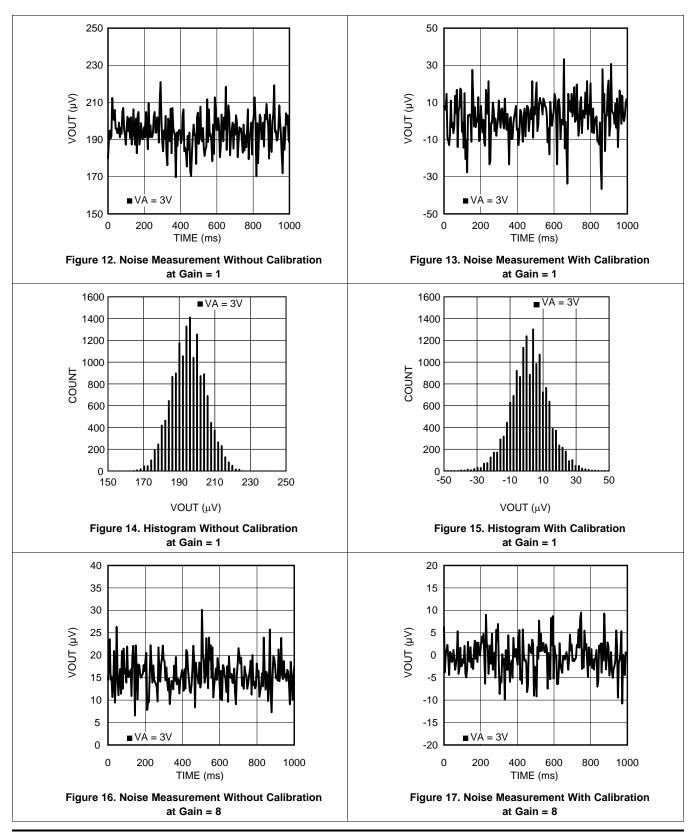
# Table 4. RMS Noise (mV) vs. Sampling Rate and Gain At $V_A = V_{IO} = V_{REF} = 5V$

SPS				GAIN OF	THE ADC			
555	1	2	4	8	16	32	64	128
1.6775	2.68	1.65	1.24	1.00	0.22	0.19	0.17	0.16
3.355	3.86	2.36	1.78	1.47	0.34	0.27	0.22	0.22
6.71	5.23	3.49	2.47	2.09	0.44	0.34	0.30	0.32
13.42	7.94	5.01	3.74	2.94	0.61	0.50	0.45	0.43
26.83125	2.90	1.86	1.34	1.08	0.29	0.24	0.23	0.23
53.6625	4.11	2.60	1.90	1.50	0.39	0.35	0.32	0.31
107.325	5.74	3.72	2.72	2.11	0.56	0.48	0.46	0.44
214.65	8.25	5.31	3.82	2.97	0.79	0.68	0.64	0.63



#### 8.12 Typical Characteristics

Unless otherwise noted, specified limits apply for VA = VIO = VREF = 3.0 V. The maximum and minimum values apply for  $T_A = T_{MIN}$  to  $T_{MAX}$ ; the typical values apply for  $T_A = 25^{\circ}$ C.

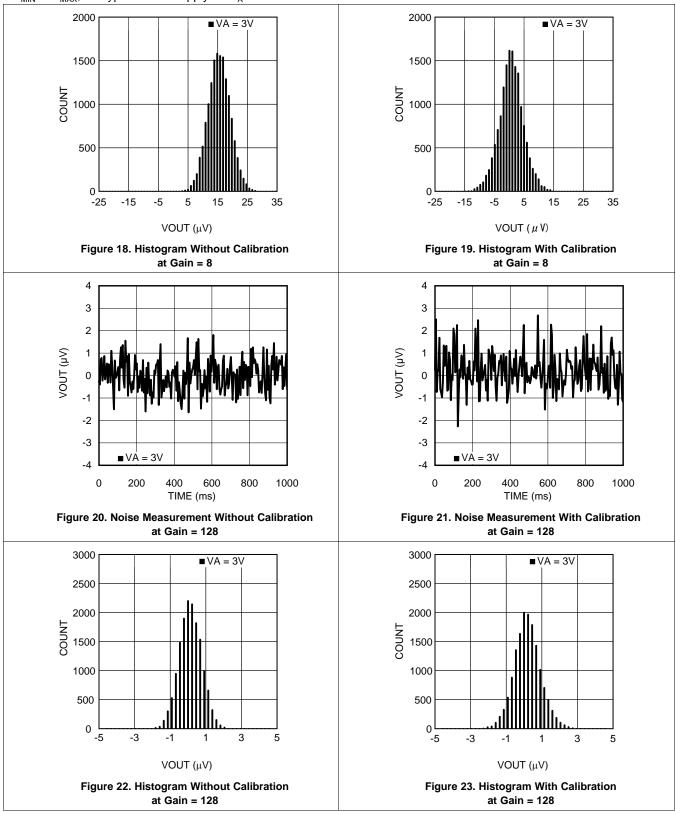


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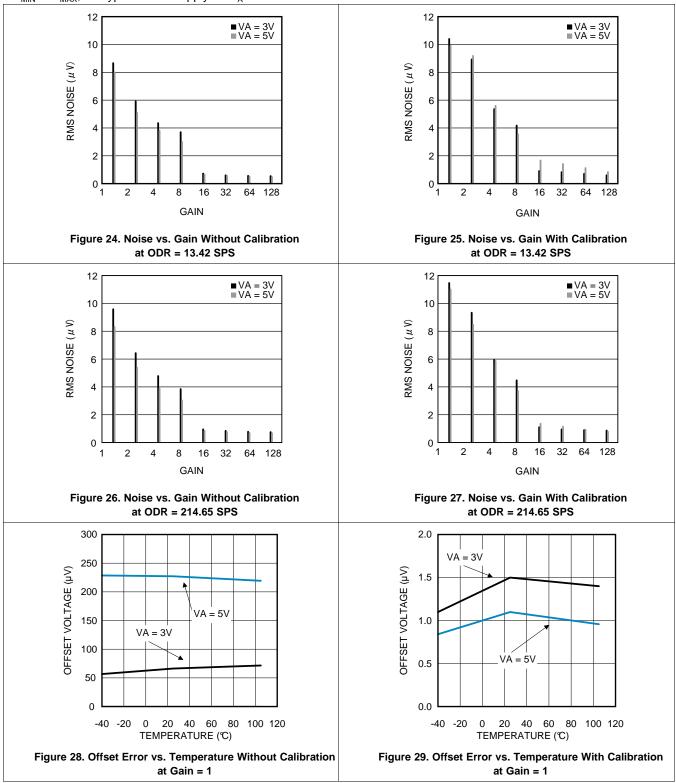
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# **Typical Characteristics (continued)**



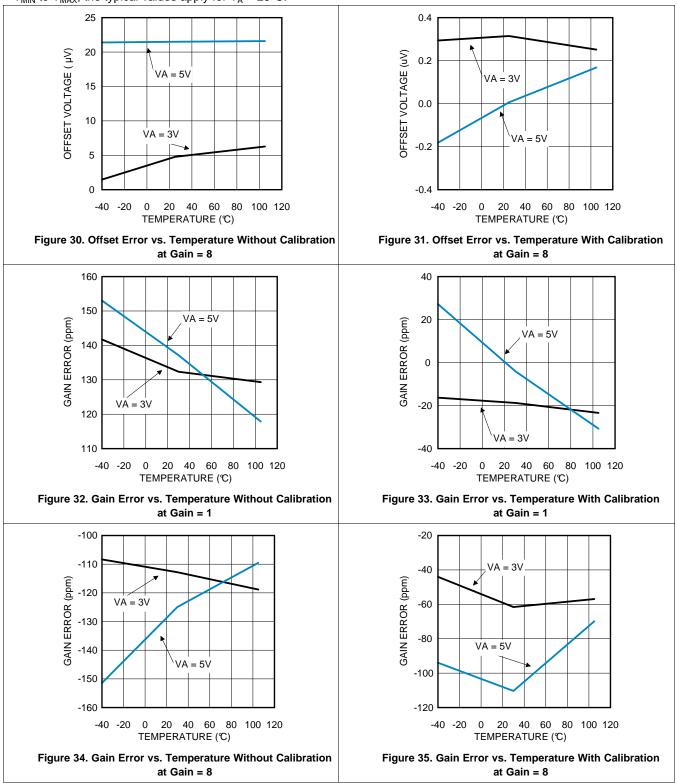


### **Typical Characteristics (continued)**



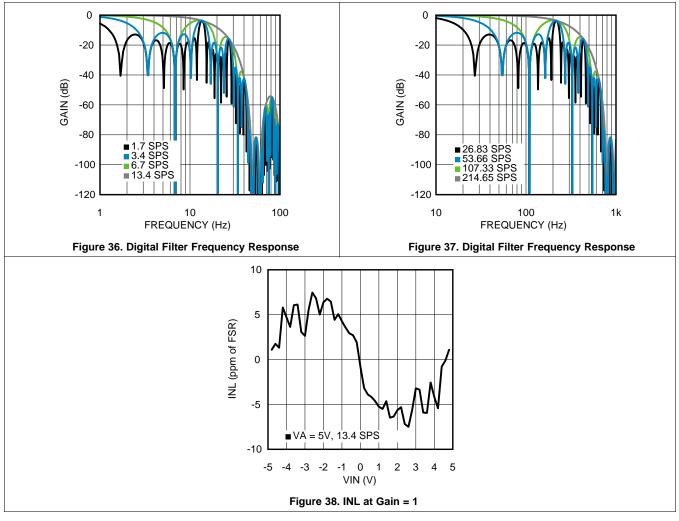
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### **Typical Characteristics (continued)**





### **Typical Characteristics (continued)**



### 9 Detailed Description

### 9.1 Overview

Throughout this datasheet, the LMP90080/LMP90079/LMP90078/LMP90077 will be referred to as the LMP900xx.

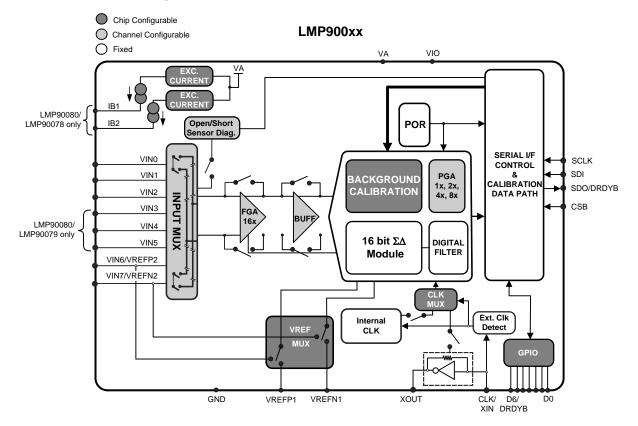
The LMP900xx is a low-power 16-Bit  $\Sigma\Delta$  ADC with 4 fully differential/7 single-ended analog channels for the LMP90080/LMP90079 and 2 full differential/4 single-ended for the LMP90078/LMP90077. Its serial data output is two's complement format. The output data rate (ODR) ranges from 1.6775 SPS to 214.65 SPS.

The serial communication for LMP900xx is SPI, a synchronous serial interface that operates using 4 pins: chip select bar (CSB), serial clock (SCLK), serial data in (SDI), and serial data out / data ready bar (SDO/DRDYB).

True continuous built-in offset and gain background calibration is also available to improve measurement accuracy. Unlike other ADCs, the LMP900xx's background calibration can run without heavily impacting the input signal. This unique technique allows for positive as well as negative gain calibration and is available at all gain settings.

The registers can be found in the *Register Maps* section, and a detailed description of the LMP900xx are provided in the following sections.

### 9.2 Functional Block Diagram





#### 9.3 Feature Description

#### 9.3.1 Calibration

As seen in Figure 39, there are two types of calibration: background calibration and system calibration. These calibrations are further described in the next sections.

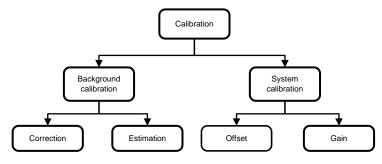


Figure 39. Types of Calibration

#### 9.3.1.1 Background Calibration

Background calibration is the process of continuously determining and applying the offset and gain calibration coefficients to the output codes to minimize the LMP900xx's offset and gain errors. Background calibration is a feature built into the LMP900xx and is automatically done by the hardware without interrupting the input signal.

Four differential channels, CH0-CH3, each with its own gain and ODRs, can be calibrated to improve the accuracy.

#### 9.3.1.1.1 Types of Background Calibration:

Figure 39 also shows that there are two types of background calibration:

**Type 1: Correction** the process of continuously determining and applying the offset and gain calibration coefficients to the output codes to minimize the LMP900xx's offset and gain errors.

This method keeps track of changes in the LMP900xx's gain and offset errors due to changes in the operating condition such as voltage, temperature, or time.

Type 2: Estimation the process of determining and continuously applying the last known offset and gain calibration coefficients to the output codes to minimize the LMP900xx's offset and gain errors.

The last known offset or gain calibration coefficients can come from two sources. The first source is the default coefficient which is pre-determined and burnt in the device's non-volatile memory. The second source is from a previous calibration run of Type 1: Correction.

The benefits of using Type 2 calibration is a higher throughput, lower power consumption, and slightly better noise. The exact savings would depend on the number of channels being scanned, and the ODR and gain of each channel.

#### 9.3.1.1.2 Using Background Calibration:

There are four modes of background calibration, which can be programmed using the BGCALCN bits. They are as follows:

- BgcalMode0: Background Calibration OFF
- BgcalMode1: Offset Correction / Gain Estimation
- BgcalMode2: Offset Correction / Gain Correction. Follow Figure 40 to set other appropriate registers when using this mode.
- BgcalMode3: Offset Estimation / Gain Estimation

### Feature Description (continued)

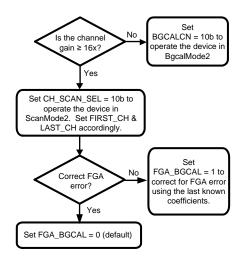


Figure 40. BgcalMode2 Register Settings

If operating in BgcalMode2, four channels (with the same ODR) are being converted, and FGA\_BGCAL = 0 (default), then the ODR is reduced by:

- 1. 0.19% of 1.6775 SPS
- 2. 0.39% of 3.355 SPS
- 3. 0.78% of 6.71 SPS
- 4. 1.54% of 13.42 SPS
- 5. 3.03% of 26.83125 SPS
- 6. 5.88% of 53.6625 SPS
- 7. 11.11% of 107.325 SPS
- 8. 20% of 214.65 SPS

#### 9.3.1.2 System Calibration

The LMP900xx provides some unique features to support easy system offset and system gain calibrations.

The System Calibration Offset Registers (CHx\_SCAL\_OFFSET) hold the System Calibration Offset Coefficients in 16-bit, two's complement binary format. The System Calibration Gain Registers (CHx\_SCAL\_GAIN) hold the System Calibration Gain Coefficient in 16-bit, 1.15, unsigned, fixed-point binary format. For each channel, the System Calibration Offset coefficient is subtracted from the conversion result prior to the division by the System Calibration Gain coefficient.

A data-flow diagram of these coefficients can be seen in Figure 41.

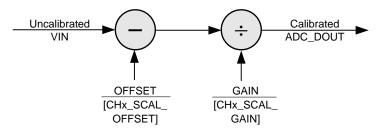


Figure 41. System Calibration Data-Flow Diagram

There are four distinct sets of System Calibration Offset and System Calibration Gain Registers for use with CH0-CH3. CH4-CH6 reuse the registers of CH0-CH2, respectively.



#### **Feature Description (continued)**

The LMP900xx provides two system calibration modes that automatically fill the Offset and Gain coefficients for each channel. These modes are the System Calibration Offset Coefficient Determination mode and the System Calibration Gain Coefficient Determination mode. The System Calibration Offset Coefficient Determination mode must be entered prior to the System Calibration Gain Coefficient Determination mode.

The system zero-scale condition is a system input condition (sensor loading) for which zero (0x0000) systemcalibrated output code is desired. It may not, however, cause a zero input voltage at the input of the ADC.

The system reference-scale condition is usually the system full-scale condition in which the system's input (or sensor's loading) would be full-scale and the desired system-calibrated output code would be 0x8000 (unsigned 16-bit binary). However, system full-scale condition need not cause full-scale input voltage at the input of the ADC.

The system reference-scale condition is not restricted to just the system full-scale condition. In fact, it can be any arbitrary fraction of full-scale (up to 1.25 times) and the desired system-calibrated output code can be any appropriate value (up to 0xA000). The CHx\_SCAL\_GAIN register must be written with the desired system-calibrated output code (default:0x8000) before entering the System Calibration Gain Coefficient Determination mode. This helps in in-place system calibration.

#### 9.3.1.2.1 System Calibration Offset Coefficient Determination Mode

Below are the detailed procedures for using the System Calibration Offset Coefficient Determination and System Calibration Gain Coefficient Determination modes.

- 1. Apply system zero-scale condition to the channel (CH0/CH1/CH2/CH3).
- 2. Enter the System Calibration Offset Coefficient Determination mode by programming 0x1 in the SCALCN register.
- 3. LMP900xx starts a fresh conversion at the selected output data rate for the selected channel. At the end of the conversion, the CHx\_SCAL\_OFFSET register is filled-in with the System Calibration Offset coefficient.
- 4. The System Calibration Offset Coefficient Determination mode is automatically exited.
- 5. The computed calibration coefficient is accurate only to the effective resolution of the device and will probably contain some noise. The noise factor can be minimized by computing over many times, averaging (externally) and putting the resultant value back into the register. Alternatively, select the output data rate to be 26.83 SPS or 1.67 SPS.

#### 9.3.1.2.2 System Calibration Gain Coefficient Determination Mode

- 1. Repeat the System Calibration Offset Coefficient Determination to calibrate the System offset for the channel.
- 2. Apply the system reference-scale condition to the channel CH0/CH1/CH2/CH3.
- 3. In the CHx\_SCAL\_GAIN register, program the expected (desired) system-calibrated output code for this condition in 16-bit unsigned format.
- 4. Enter the System Calibration Gain Coefficient Determination mode by programming 0x3 in the SCALCN register.
- 5. LMP900xx starts a fresh conversion at the selected output data rate for the channel. At the end of the conversion, the CHx\_SCAL\_GAIN is filled-in (or overwritten) with the System Calibration Gain coefficient.
- 6. The System Calibration Gain Coefficient Determination mode is automatically exited.
- 7. The computed calibration coefficient is accurate only to the effective resolution of the device and will probably contain some noise. The noise factor can be minimized by computing over many times, averaging (externally) and putting the resultant value back into the register. Alternatively, select the output data rate to be 26.83 SPS or 1.67 SPS.

#### Feature Description (continued)

#### 9.3.1.2.3 Post-Calibration Scaling

LMP900xx allows scaling (multiplication and shifting) for the System Calibrated result. This eases downstream processing, if any. Multiplication is done using the System Calibration Scaling Coefficient in the CHx\_SCAL\_SCALING register and shifting is done using the System Calibration Bits Selector in the CHx\_SCAL\_BITS\_SELECTOR register.

The System Calibration Bits Selector value should ideally be the logarithm (to the base 2) of the System Calibration Scaling Coefficient value.

There are four distinct sets of System Calibration Scaling and System Calibration Bits Selector Registers for use with CH0-CH3. CH4-CH6 reuse the registers of CH0-CH2, respectively.

A data-flow diagram of these coefficients can be seen in Figure 42.

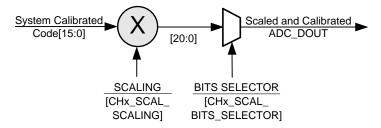


Figure 42. Post-Calibration Scaling Data-Flow Diagram

#### 9.3.2 True Continuous Background Calibration

The LMP90080/LMP90079/LMP90078/LMP90077 feature a 16-bit  $\Sigma\Delta$  core with continuous background calibration to compensate for gain and offset errors in the ADC, virtually eliminating any drift with time and temperature. The calibration is performed in the background without user or ADC input interruption, making it unique in the industry and eliminating down time associated with field calibration required with other solutions. Having this continuous calibration improves performance over the entire life span of the end product.

#### 9.3.3 Continuous Background Sensor Diagnostics

Sensor diagnostics are also performed in the background, without interfering with signal path performance, allowing the detection of sensor shorts, opens, and out-of-range signals, which vastly improves system reliability. In addition, the fully flexible input multiplexer described below allows any input pin to be connected to any ADC input channel providing additional sensor path diagnostic capability.

#### 9.3.4 Flexible Input MUX Channels

The flexible input MUX allows interfacing to a wide range of sensors such as thermocouples, RTDs, thermistors, and bridge sensors. The LMP90080/LMP90079's multiplexer supports 4 differential channels while the LMP90078/LMP90077 supports 2. Each effective input voltage that is digitized is  $V_{IN} = V_{INX} - V_{INY}$ , where x and y are any input. In addition, the input multiplexer of the LMP90080/LMP90079 also supports 7 single-ended channels (LMP90078/LMP90077 supports 4), where the common ground is any one of the inputs.

#### 9.3.5 Programmable Gain Amplifiers (FGA & PGA)

The LMP90080/LMP90079/LMP90078/LMP90077 contain an internal 16x fixed gain amplifier (FGA) and a 1x, 2x, 4x, or 8x programmable gain amplifier (PGA). This allows accurate gain settings of 1x, 2x, 4x, 8x, 16x, 32x, 64x, or 128x through configuration of internal registers. Having an internal amplifier eliminates the need for external amplifiers that are costly, space consuming, and difficult to calibrate.

#### 9.3.6 Excitation Current Sources (IB1 & IB2) - LMP90080/LMP90078

Two matched internal excitation currents, IB1 and IB2, can be used for sourcing currents to a variety of sensors. The current range is from 100  $\mu$ A to 1000  $\mu$ A in steps of 100  $\mu$ A.



### Feature Description (continued)

#### 9.3.7 Signal Path

#### 9.3.7.1 Reference Input (V<sub>REF</sub>)

The differential reference voltage  $V_{REF}$  ( $V_{REFP} - V_{REFN}$ ) sets the range for  $V_{IN}$ .

The muxed V<sub>REF</sub> allows the user to choose between V<sub>REF1</sub> or V<sub>REF2</sub> for each channel. This selection can be made by programming the V<sub>REF\_SEL</sub> bit in the CHx\_INPUTCN registers (CHx\_INPUTCN: V<sub>REF\_SEL</sub>). The default mode is V<sub>REF1</sub>. If V<sub>REF2</sub> is used, then V<sub>IN6</sub> and V<sub>IN7</sub> cannot be used as inputs because they share the same pin.

Refer to  $V_{REF}$  for  $V_{REF}$  applications information.

#### 9.3.7.2 Flexible Input MUX (VIN)

LMP900xx provides a flexible input MUX as shown in Figure 43. The input that is digitized is  $V_{IN} = V_{INP} - V_{INN}$ ; where  $V_{INP}$  and  $V_{INN}$  can be any available input.

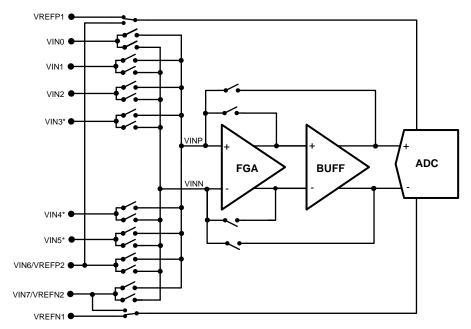
The digitized input is also known as a channel, where  $CH = V_{IN} = V_{INP} - V_{INN}$ . Thus, there are a maximum of 4 differential channels: CH0, CH1, CH2, and CH3 for the LMP90080/LMP90079. The LMP90078/LMP90077 has 2 differential channels: CH0 and CH1 because it does not have the  $V_{IN3}$ ,  $V_{IN4}$ , and  $V_{IN5}$  pins.

LMP900xx can also be configured single-ended, where the common ground is any one of the inputs. There are a maximum of 7 single-ended channels: CH0, CH1, CH2, CH3, CH4, CH5, and CH6 for the LMP90080/LMP90079 and 4: CH0, CH1, CH2, CH3 for the LMP90078/LMP90077.

The input MUX can be programmed in the CHx\_INPUTCN registers. For example on the LMP90080, to program CH0 =  $V_{IN} = V_{IN4} - V_{IN1}$ , go to the CH0\_INPUTCN register and set:

1.  $V_{INP} = 0x4$ 

2. 
$$V_{INN} = 0x1$$



\* VIN3, VIN4, VIN5 are only available for LMP90080 and LMP90079

Figure 43. Simplified VIN Circuitry



#### **Feature Description (continued)**

#### 9.3.7.3 Selectable Gains (FGA and PGA)

LMP900xx provides two types of gain amplifiers: a fixed gain amplifier (FGA) and a programmable gain amplifier (PGA). FGA has a fixed gain of 16x or it can be bypassed, while the PGA has programmable gain settings of 1x, 2x, 4x, or 8x.

Total gain is defined as FGA x PGA. Thus, LMP900xx provides gain settings of 1x, 2x, 4x, 8x, 16x, 32x, 64x, or 128x with true continuous background calibration.

The gain is channel specific, which means that one channel can have one gain, while another channel can have the same or a different gain.

The gain can be selected by programming the CHx\_CONFIG: GAIN\_SEL bits.

#### 9.3.7.4 Buffer (BUFF)

There is an internal unity gain buffer that can be included or excluded from the signal path. Including the buffer provides a high input impedance but increases the power consumption.

When gain  $\geq$  16, the buffer is automatically included in the signal path. When gain < 16, including or excluding the buffer from the signal path can be done by programming the CHX\_CONFIG: BUF\_EN bit.

#### 9.3.7.5 Internal/External CLK Selection

LMP900xx allows two clock options: internal CLK or external CLK (crystal (XTAL) or clock source).

There is an "External Clock Detection" mode, which detects the external XTAL if it is connected to XOUT and XIN. When operating in this mode, the LMP900xx shuts off the internal clock to reduce power consumption. Below is a flow chart to help set the appropriate clock registers.

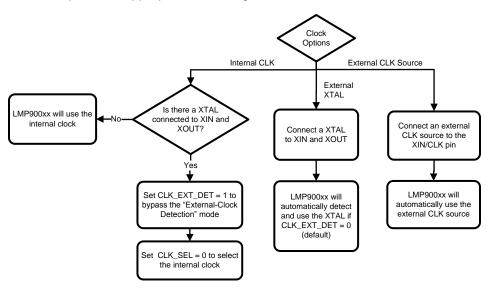


Figure 44. CLK Register Settings

The recommended value for the external CLK is discussed in the next sections.



#### Feature Description (continued)

#### 9.3.7.6 Programmable ODRS

If using the internal CLK or external CLK of 3.5717 MHz, then the output date rates (ODR) can be selected (using the ODR\_SEL bit) as:

- 1. 13.42/8 = 1.6775 SPS
- 2. 13.42/4 = 3.355 SPS
- 3. 13.42/2 = 6.71SPS
- 4. 13.42 SPS
- 5. 214.65/8 = 26.83125 SPS
- 6. 214.65/4 = 53.6625 SPS
- 7. 214.65/2 = 107.325 SPS
- 8. 214.65 SPS (default)

If the internal CLK is not being used and the external CLK is not 3.5717 MHz, then the ODR will be different. If this is the case, use the equation below to calculate the new ODR values.

ODR_Base1 = (CLK <sub>EXT</sub> ) / (266,240)	(1)
$ODR_Base2 = (CLK_{EXT}) / (16,640)$	(2)
ODR1 = (ODR_Base1) / n, where n = 1,2,4,8	(3)
ODR2 = (ODR_Base2) / n, where n = 1,2,4,8	(4)
r example, a 3.6864 MHz XTAL or external clock has the following ODR values:	

For example, a 3.6864 MHz XTAL or external clock has the following ODR values:

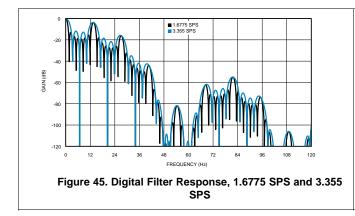
$ODR_BaseT = (3.6864 MHZ) / (266,240) = 13.85 SPS$	(5)
ODR_Base2 = (3.6864 MHz) / (16,640) = 221.54 SPS	(6)
ODR1 = (13.85 SPS) / n = 13.85, 6.92, 3.46, 1.73 SPS	(7)
ODR2 = (221.54 SPS) / n = 221.54, 110.77, 55.38, 27.69 SPS	(8)

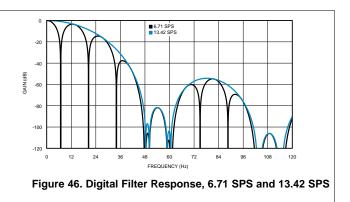
The ODR is channel specific, which means that one channel can have one ODR, while another channel can have the same or a different ODR.

Note that these ODRs are meant for a single channel conversion; the ODR needs to be divided by n for n channels scanning. For example, if the ADC were running at 214.65 SPS and four channels are being scanned, then the ODR per channel would be 214.65/4 = 53.6625 SPS.

#### 9.3.7.7 Digital Filter

The LMP900xx has a fourth order rotated sinc filter that is used to configure various ODRs and to reject power supply frequencies of 50Hz and 60Hz. The 50/60 Hz rejection is only effective when the device is operating at ODR  $\leq$  13.42 SPS. If the internal CLK or the external CLK of 3.5717 MHz is used, then the LMP900xx will have the frequency response shown in Figure 45 through Figure 49.

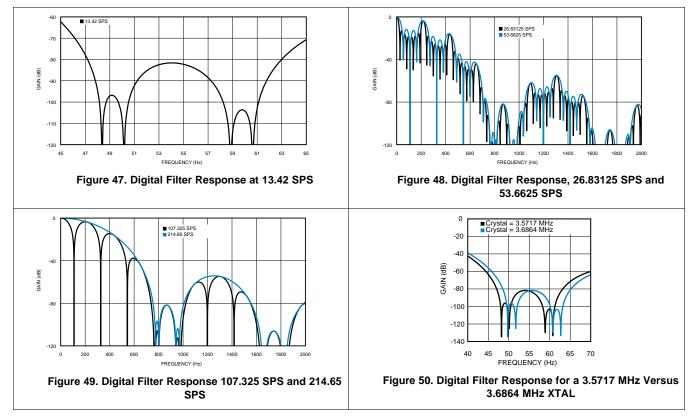




(\_)



### Feature Description (continued)



If the internal CLK is not being used and the external CLK is not 3.5717 MHz, then the filter response would be the same as the response shown above, but the frequency will change according to the equation:

 $f_{NEW} = [(CLK_{EXT}) / 256] x (f_{OLD} / 13.952k)$ 

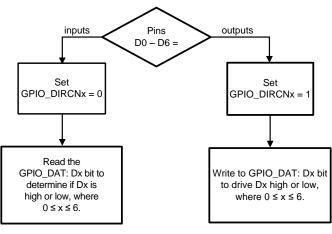
(9)

Using Equation 9, an example of the filter response for a 3.5717 MHz XTAL versus a 3.6864 MHz XTAL can be seen in Figure 50.

### 9.3.7.8 GPIO (D0–D6)

Pins D0-D6 are general purpose input/output (GPIO) pins that can be used to control external LEDs or switches. Only a high or low value can be sourced to or read from each pin.

Figure 51 shows a flowchart how these GPIOs can be programmed.







#### 9.4 Device Functional Modes

#### 9.4.1 Channels Scan Mode

There are four scan modes. These scan modes are selected using the CH\_SCAN: CH\_SCAN\_SEL bit. The first scanned channel is FIRST\_CH, and the last scanned channel is LAST\_CH; they are both located in the CH\_SCAN register.

The CH\_SCAN register is double buffered. That is, user inputs are stored in a slave buffer until the start of the next conversion during which time they are transferred to the master buffer. Once the slave buffer is written, subsequent updates are disregarded until a transfer to the master buffer happens. Hence, it may be appropriate to check the CH\_SCAN\_NRDY bit before programming the CH\_SCAN register.

#### 9.4.1.1 ScanMode0: Single-Channel Continuous Conversion

LMP900xx continuously converts the selected FIRST\_CH.

Do not operate in this scan mode if gain  $\geq$  16 and the LMP900xx is running in background calibration modes BgcalMode1 or BgcalMode2. If this is the case, then it is more suitable to operate the device in ScanMode2 instead.

#### 9.4.1.2 ScanMode1: Multiple-Channels Single Scan

LMP900xx converts one or more channels starting from FIRST\_CH to LAST\_CH, and then enters the stand-by state.

#### 9.4.1.3 ScanMode2: Multiple-Channels Continuous Scan

LMP900xx continuously converts one or more channels starting from FIRST\_CH to LAST\_CH, and then it repeats this process.

#### 9.4.1.4 ScanMode3: Multiple-Channels Continuous Scan with Burnout Currents

This mode is the same as ScanMode2 except that the burnout current is provided in a serially scanned fashion (injected in a channel after it has undergone a conversion). Thus it avoids burnout current injection from interfering with the conversion result for the channel.

The sensor diagnostic burnout currents are available for all four scan modes. The burnout current is further gated by the BURNOUT\_EN bit for each channel. ScanMode3 is the only mode that scans multiple channels while injecting burnout currents without interfering with the signal. This is described in details in *Burnout Currents*.

#### 9.4.2 Sensor Interface

The LMP90080/LMP90078 contains two excitation currents (IB1 & IB2) for sourcing external sensors, and the LMP900xx contain two burnout currents for sensor diagnostics. They are described in the next sections.

#### 9.4.2.1 IB1 & IB2 - Excitation Currents (LMP90080/LMP90078)

IB1 and IB2 can be used for providing currents to external sensors, such as RTDs or bridge sensors. 100μA to 1000μA, in steps of 100μA, can be sourced by programming the ADC\_AUXCN: RTD\_CUR\_SEL bits.

Refer to 3-Wire RTD to see how IB1 and IB2 can be used to source a 3-wire RTD.

#### **Device Functional Modes (continued)**

#### 9.4.2.2 Burnout Currents

As shown in Figure 52, the LMP900xx contains two internal 10  $\mu$ A burnout current sources, one sourcing current from V<sub>A</sub> to V<sub>INP</sub>, and the other sinking current from V<sub>INN</sub> to ground. These currents are used for sensor diagnostics and can be enabled for each channel using the CHx\_INPUTCN: BURNOUT\_EN bit.

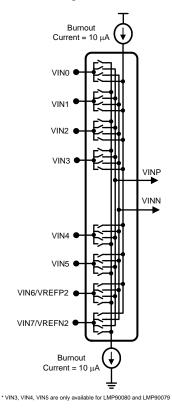


Figure 52. Burnout Currents

#### 9.4.2.2.1 Burnout Current Injection

Burnout currents are injected differently depending on the channel scan mode selected.

When BURNOUT\_EN = 1 and the device is operating in ScanMode0, 1, or 2, the burnout currents are injected into all the channels for which the BURNOUT\_EN bit is selected. This will cause problems and hence in this mode, more than one channel should not have its BURNOUT\_EN bit selected. Also, the burnout current will interfere with the signal and introduce a fixed error depending on the particular external sensor.

When BURNOUT\_EN = 1 and the device is operating in ScanMode3, burnout currents are injected into the last sampled channel on a cyclical basis (Figure 53). In this mode, burnout currents injection is truly done in the background without affecting the accuracy of the on-going conversion. Operating in this mode is recommended.



### **Device Functional Modes (continued)**

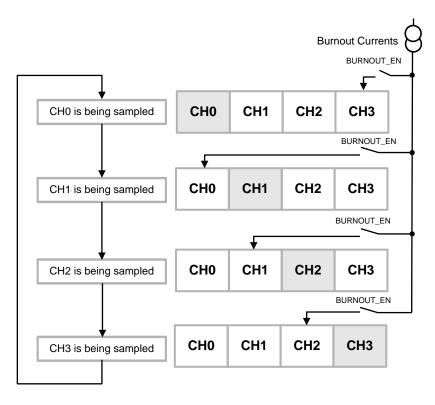


Figure 53. Burnout Currents Injection for Scanmode3

### 9.4.2.3 Sensor Diagnostic Flags

Burnout currents can be used to verify that an external sensor is still operational before attempting to make measurements on that channel. A non-operational sensor means that there is a possibility the connection between the sensor and the LMP900xx is open circuited, short circuited, shorted to  $V_A$  or GND, overloaded, or the reference may be absent. The sensor diagnostic flags diagram can be seen in Figure 54.

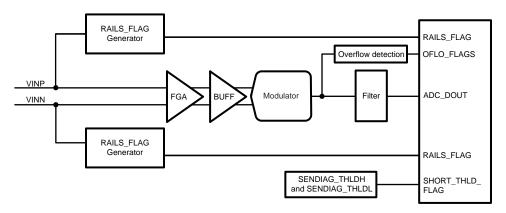


Figure 54. Sensor Diagnostic Flags Diagram

The sensor diagnostic flags are located in the SENDIAG\_FLAGS register and are described in further details below.

### **Device Functional Modes (continued)**

#### 9.4.2.3.1 SHORT\_THLD\_FLAG

The short circuit threshold flag is used to report a short-circuit condition. It is set when the output voltage ( $V_{OUT}$ ) is within the absolute  $V_{threshold}$ .  $V_{threshold}$  can be programmed using the 8-bit SENDIAG\_THLDH register.

For example, assume  $V_{REF} = 5V$ , gain = 1, SENDIAG\_THLD = 0xDA (218d). In this case,  $V_{threshold}$  can be calculated as:

 $\begin{array}{ll} V_{threshold} = [(SENDIAG_THLD)(2)(V_{REF})] / [(Gain)(2^{16})] & (10) \\ V_{threshold} = [(218)(2)(5V)] / [(1)(2^{16})] & (11) \\ V_{threshold} = 33.3 \ \text{mV} & (12) \\ \end{array}$  (10)  $\begin{array}{ll} V_{threshold} = 33.3 \ \text{mV} & (12) \\ \end{array}$  (12) When (-33.3mV)  $\leq V_{OUT} \leq (33.3\text{mV})$ , then SHORT\_THLD\_FLAG = 1; otherwise, SHORT\_THLD\_FLAG = 0. \\ \end{array}

#### 9.4.2.3.2 RAILS\_FLAG

The rails flag is used to detect if one of the sampled channels is within 50mV of the rails potential ( $V_A$  or  $V_{SS}$ ). This can be further investigated to detect an open-circuit or short-circuit condition. If the sampled channel is near a rail, then RAILS\_FLAG = 1; otherwise, RAILS\_FLAG = 0.

#### 9.4.2.3.3 POR\_AFT\_LST\_RD

If POR\_AFT\_LST\_READ = 1, then there was a power-on reset since the last time the SENDIAG\_FLAGS register was read. This flag's status is cleared when this bit is read, unless this bit is set again on account of another power-on-reset event in the intervening period.

#### 9.4.2.3.4 OFLO\_FLAGS

OFLO\_FLAGS is used to indicate whether the modulator is over-ranged or under-ranged. The following conditions are possible:

- 1. OFLO\_FLAGS = 0x0: Normal Operation
- 2. OFLO\_FLAGS = 0x1: The differential input is more than  $(\pm V_{REF}/Gain)$  but is not more than  $\pm (1.3*V_{REF}/Gain)$  to cause a modulator over-range.
- 3. OFLO\_FLAGS = 0x2: The modulator was over-ranged towards +V<sub>REF</sub>/Gain.
- 4. OFLO\_FLAGS = 0x3: The modulator was over-ranged towards  $-V_{REF}$ /Gain.

The condition of OFLO\_FLAGS = 10b or 11b can be used in conjunction with the RAILS\_FLAG to determine the fault condition.

#### 9.4.2.3.5 SAMPLED\_CH

These three bits show the channel number for which the ADC\_DOUT and SENDIAG\_FLAGS are available. This does not necessarily indicate the current channel under conversion because the conversion frame and computation of results from the channels are pipelined. That is, while the conversion is going on for a particular channel, the results for the previous conversion (of the same or a different channel) are available.

#### 9.5 Programming

#### 9.5.1 Serial Digital Interface

A synchronous 4-wire serial peripheral interface (SPI) provides access to the internal registers of LMP900xx via CSB, SCLK, SDI, SDO/DRDYB.

#### 9.5.1.1 Register Address (ADDR)

All registers are memory-mapped. A register address (ADDR) is composed of an upper register address (URA) and lower register address (LRA) as shown in Table 5. For example, ADDR 0x3A has URA=0x3 and LRA=0xA.

BIT	[6:4]	[3:0]
Name	URA	LRA

#### Table 5. ADDR Map



#### 9.5.1.2 Register Read/Write Protocol

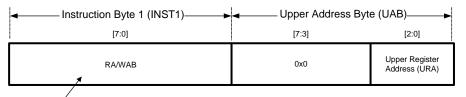
Figure 55 shows the protocol how to write to or read from a register.

Transaction 1 sets up the upper register address (URA) where the user wants to start the register-write or register-read.

Transaction 2 sets the lower register address (LRA) and includes the Data Byte(s), which contains the incoming data from the LMP900xx.

Examples of register-reads or register-writes can be found in *Register Read/Write Examples*.

Transaction 1 – URA Setup – necessary only when the previous URA is different than the desired URA.



<u>R/WB = Read/Write Address</u> 0x10: Write Address 0x90: Read Address

#### Transaction 2 – Data Access

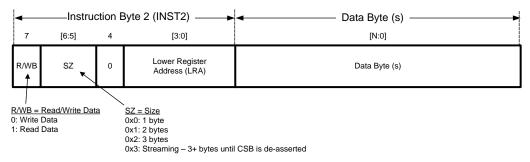


Figure 55. Register Read/Write Protocol

#### 9.5.1.3 Streaming

When writing/reading 3+ bytes, the user must operate the device in Normal Streaming mode or Controlled Streaming mode. In the Normal Streaming mode, which is the default mode, data runs continuously starting from ADDR until CSB deasserts. This mode is especially useful when programming all the configuration registers in a single transaction. See the *Normal Streaming Example* section for an example of the Normal Streaming mode.

In the Controlled Streaming mode, data runs continuously starting from ADDR until the data has run through all (STRM\_RANGE + 1) registers. For example, if the starting ADDR is 0x1C, STRM\_RANGE = 5, then data will be written to or read from the following ADDRs: 0x1C, 0x1D, 0x1E, 0x1F, 0x20, 0x21. Once the data reaches ADDR 0x21, LMP900xx will wrap back to ADDR 0x1C and repeat this process until CSB deasserts. See the *Controlled Streaming Example* section for an example of the Controlled Streaming mode.

If streaming reaches ADDR 0x7F, then it will wrap back to ADDR 0x00. Furthermore, reading back the Upper Register Address after streaming will report the Upper Register Address at the start of streaming, not the Upper Register Address at the end of streaming.

To stream, write 0x3 to INST2's SZ bits as seen in Figure 55. To select the stream type, program the SPI\_STREAMCN: STRM\_TYPE bit. The STRM\_RANGE can also be programmed in the same register.

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#### 9.5.1.4 CSB – Chip Select Bar

An SPI transaction begins when the master asserts (active low) CSB and ends when the master deasserts (active high) CSB. Each transaction might be separated by a subsequent one with a CSB deassertion, but this is optional. Once CSB is asserted, it must not pulse (deassert and assert again) during a (desired) transaction.

CSB can be grounded in systems where LMP900xx is the only SPI slave. This frees the software from handling the CSB. Care has to be taken to avoid any false edge on SCLK, and while operating in this mode, the streaming transaction should not be used because exiting from this mode can only be done through a CSB deassertion.

#### 9.5.1.5 SPI Reset

SPI Reset resets the SPI-Protocol State Machine by monitoring the SDI for at least 73 consecutive 1's at each SCLK rising edge. After an SPI Reset, SDI is monitored for a possible Write Instruction at each SCLK rising edge.

SPI Reset will reset the Upper Address Register (URA) to 0, but the register contents are not reset.

By default, SPI reset is disabled, but it can be enabled by writing 0x01 to SPI Reset Register (ADDR 0x02).

#### 9.5.1.6 DRDYB - Data Ready Bar

DRDYB is a signal generated by the LMP900xx that indicates a fresh conversion data is available in the ADC\_DOUT registers.

DRDYB is automatically asserted every (1/ODR) second as seen in Figure 56. Before the next assertion, DRDYB will pulse for  $t_{DRDYB}$  second. The value for  $t_{DRDYB}$  can be found in Timing Requirements.



Figure 56. DRDYB Behavior

If ADC\_DOUT is being read while a new ADC\_DOUT becomes available, then the ADC\_DOUT that is being read is still valid (Figure 57). DRDYB will still be deasserted every 1/ODR second, but a consecutive read on the ADC\_DOUT register will fetch the newly converted data available.

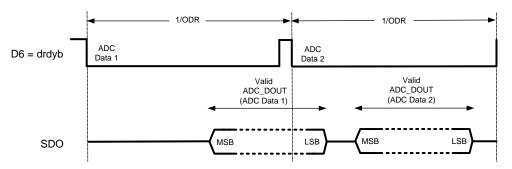


Figure 57. DRDYB Behavior For An Incomplete ADC\_DOUT Reading

DRDYB can also be accessed via registers using the DT\_AVAIL\_B bit. This bit indicates when fresh conversion data is available in the ADC\_DOUT registers. If new conversion data is available, then DT\_AVAIL\_B = 0; otherwise, DT\_AVAIL\_B = 1.

A complete reading for DT\_AVAIL\_B occurs when the MSB of ADC\_DOUTH is read out. This bit cannot be reset even if REG\_AND\_CNV\_RST = 0xC3.



#### 9.5.1.6.1 DrdybCase1: Combining SDO/DRDYB with SDO\_DRDYB\_DRIVER = 0x00

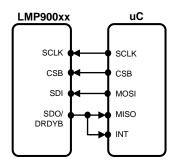
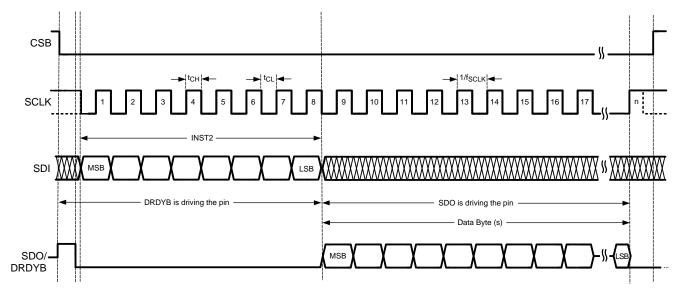


Figure 58. DrdybCase1 Connection Diagram

As shown in Figure 58, the DRDYB signal and SDO can be multiplexed on the same pin as their functions are mostly complementary. In fact, this is the default mode for the SDO/DRDYB pin.

Figure 59 shows a timing protocol for DrdybCase1. In this case, start by asserting CSB first to monitor a DRDYB assertion. When the DRDYB signal asserts, begin writing the Instruction Bytes (INST1, UAB, INST2) to read from or write to registers. Note that INST1 and UAB are omitted from the figure below because this transaction is only required if a new UAB needs to be implemented.

While the CSB is asserted, DRDYB is driving the SDO/DRDYB pin unless the device is reading data, in which case, SDO will be driving the pin. If CSB is deasserted, then the SDO/DRDYB pin is High-Z.





#### 9.5.1.6.2 DrdybCase2: Combining SDO/DRDYB with SDO\_DRDYB\_DRIVER = 0x03

SDO/DRDYB can be made independent of CSB by setting SDO\_DRDYB\_DRIVER = 0x03 in the SPI Handshake Control register. In this case, DRDYB will drive the pin unless the device is reading data, independent of the state of CSB. SDO will drive the pin when CSB is asserted and the device is reading data.

With this scheme, one can use SDO/DRDYB as a true interrupt source, independent of the state of CSB. But this scheme can only be used when the LMP900xx is the only device connected to the master's SPI bus because the SDO/DRDYB pin will be DRDYB even when CSB is deasserted.

The timing protocol for this case can be seen in Figure 60. When DRDYB asserts, assert CSB to start the SPI transaction and begin writing the Instruction Bytes (INST1, UAB, INST2) to read from or write to registers.



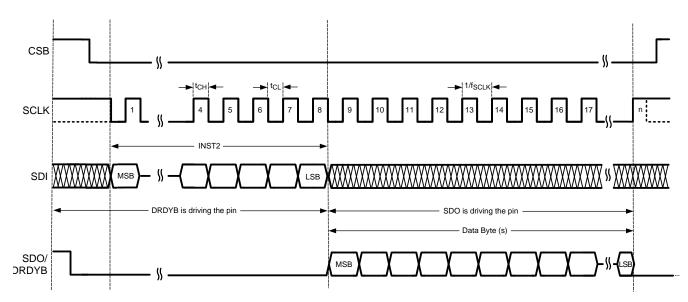
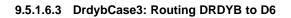


Figure 60. Timing Protocol For DrdybCase2



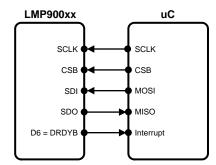


Figure 61. DrdybCase3 Connection Diagram

The DRDYB signal can be routed to pin D6 by setting SPI\_DRDYB\_D6 high and SDO\_DRDYB\_DRIVER to 0x4. This is the behavior for DrdybCase3 as shown in Figure 61.

The timing protocol for this case can be seen in Figure 62. Since DRDYB is separated from SDO, it can be monitored using the interrupt or polling method. If polled, the DRDYB signal needs to be polled faster than  $t_{DRDYB}$  to detect a DRDYB assertion. When DRDYB asserts, assert CSB to start the SPI transaction and begin writing the Instruction Bytes (INST1, UAB, INST2) to read from or write to registers.



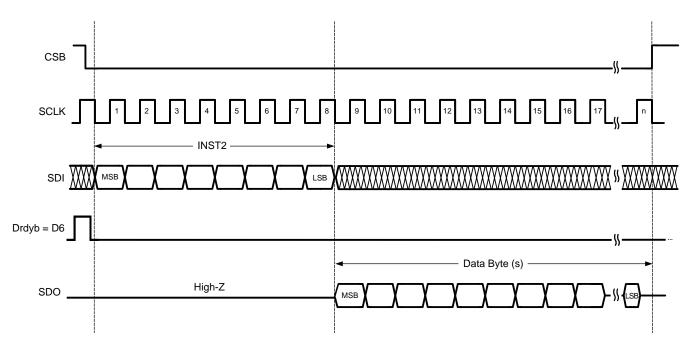


Figure 62. Timing Protocol for DrdybCase3

### 9.5.1.7 Data Only Read Transaction

In a data only read transaction, one can directly access the data byte(s) as soon as the CSB is asserted without having to send any instruction byte. This is useful as it brings down the latency as well as the overhead associated with the instruction byte (as well as the Upper Address Byte, if any).

In order to use the data only transaction, the device must be placed in the data first mode. The following table lists transaction formats for placing the device in and out of the data first mode and reading the mode status.

	BIT[7]	BITS[6:5]	BIT[4]	BITS[3:0]	DATA BYTES
Enable Data First Mode Instruction	1	11	1	1010	None
Disable Data First Mode Instruction	1	11	1	1011	None
Read Mode Status Transaction	1	00	1	1111	One

**Table 6. Data First Mode Transactions** 

Note that while being in the data first mode, once the data bytes in the data only read transaction are sent out, the device is ready to start on any normal (non-data-only) transaction including the Disable Data First Mode Instruction. The current status of the data first mode (enabled/disabled status) can be read back using the Read Mode Status Transaction. This transaction consists of the Read Mode Status Instruction followed by a single data byte (driven by the device). The data first mode status is available on bit [1] of this data byte.

The data only read transaction allows reading up to eight consecutive registers, starting from any start address. Usually, the start address will be the address of the most significant byte of conversion data, but it could just as well be any other address. The start address and number of bytes to be read during the data only read transaction can be programmed using the DATA\_ONLY\_1 AND DATA\_ONLY\_2 registers respectively.

The upper register address is unaffected by a data only read transaction. That is, it retains its setting even after encountering a data only transaction. The data only transaction uses its own address (including the upper address) from the DATA\_ONLY\_1 register. When in the data first mode, the SCLK must stop high before entering the Data Only Read Transaction; this transaction should be completed before the next scheduled DRDYB deassertion.

#### 9.5.1.8 Cyclic Redundancy Check (CRC)

CRC can be used to ensure integrity of data read from LMP900xx. To enable CRC, set EN\_CRC high. Once CRC is enabled, the CRC value is calculated and stored in SPI\_CRC\_DAT so that the master device can periodically read for data comparison. The CRC is automatically reset when CSB or DRDYB is deasserted.

The CRC polynomial is  $x^8 + x^5 + x^4 + 1$ . The reset value of the SPI\_CRC\_DAT register is zero, and the final value is ones-complemented before it is sent out. Note that CRC computation only includes the bits sent out on SDO and does not include the bits of the SPI\_CRC\_DAT itself; thus it is okay to read SPI\_CRC\_DAT repeatedly.

The DRDYB signal normally deasserts (active high) every 1/ODR second. However, this behavior can be changed so that DRDYB deassertion can occur after SPI\_CRC\_DAT is read, but not later than normal DRDYB deassertion which occurs at every 1/ODR seconds. This is done by setting bit DRDYB\_AFT\_CRC high.

The timing protocol for CRC can be found in Figure 63.

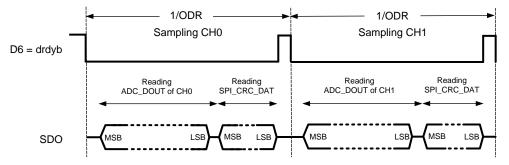
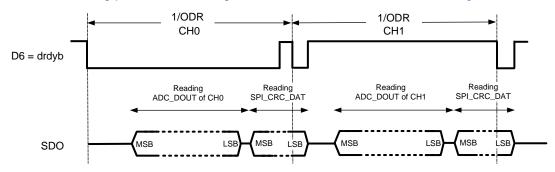


Figure 63. Timing Protocol for Reading SPI\_CRC\_DAT

If SPI\_CRC\_DAT read extends beyond the normal DRDYB deassertion at every 1/ODR seconds, then CRC\_RST has to be set in the SPI Data Ready Bar Control Register. This is done to avoid a CRC reset at the DRDYB deassertion. Timing protocol for reading CRC with CRC\_RST set is shown in Figure 64.





Follow the steps below to enable CRC:

- 1. Set SPI\_CRC\_CN = 1 (register 0x13, bit 4) to enable CRC.
- 2. Set DRDYB\_AFT\_CRC = 1 (register 0x13, bit 2) to dessert the DRDYB after CRC.
- 3. Compute the CRC externally, which should include ADC\_DOUTH and ADC\_DOUTL.
- 4. Collect the data and verify the reported CRC matches with the computed CRC (step above).



#### 9.5.2 RESET and RESTART

Writing 0xC3 to the REG\_AND\_CNV\_RST field will reset the conversion and most of the programmable registers to their default values. The only registers that will not be reset are the System Calibration Registers (CHx\_SCAL\_OFFSET, CHx\_SCAL\_GAIN) and the DT\_AVAIL\_B bit.

If it is desirable to reset the System Calibration Coefficient Registers, then set RESET\_SYSCAL = 1 before writing 0xC3 to REG\_AND\_CNV\_RST. If the device is operating in the "System Calibration Offset/Gain Coefficient Determination" mode (SCALCN register), then write REG\_AND\_CNV\_RST = 0xC3 twice to get out of this mode.

After a register reset, any on-going conversions will be aborted and restarted. If the device is in the power-down state, then a register reset will bring it out of the power-down state.

To restart a conversion, write 1 to the RESTART bit. This bit can be used to synchronize the conversion to an external event.

After a restart conversion, the first sample is not valid. To restart with a valid first sample, issue a stand-by command followed by an active command.

#### 9.5.3 Register Read/Write Examples

#### 9.5.3.1 Writing to Register Examples

Using the register read/write protocol shown in Figure 55, the following example shows how to write three data bytes starting at register address (ADDR) 0x1F. After the last byte has been written to ADDR 0x21, deassert CSB to end the register-write.

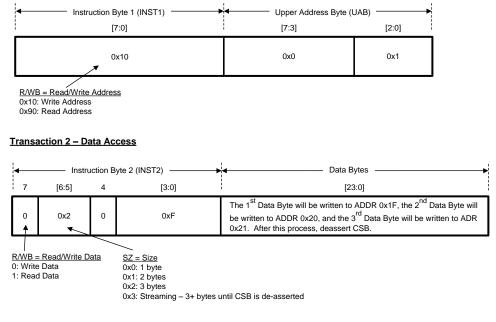


Figure 65. Register-Write Example 1

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The next example shows how to write one data byte to ADDR 0x12. Since the URA for this example is the same as the last example, transaction 1 can be omitted.

#### Transaction 2 – Data Access

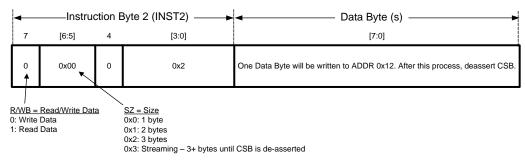


Figure 66. Register-Write Example 2

#### 9.5.3.2 Reading from Register Example

The following example shows how to read two bytes. The first byte will be read from starting ADDR 0x24, and the second byte will be read from ADDR 0x25.

Transaction 1 – URA Setup – necessary only when the previous URA is different than the desired URA.

Instruction Byte 1 (INST1)	Upper Address Byte	e (UAB)
[7:0]	[7:3]	[2:0]
0x10	0x0	0x2

<u>R/WB = Read/Write Address</u> 0x10: Write Address 0x90: Read Address

#### Transaction 2 – Data Access

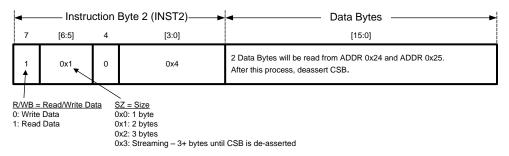


Figure 67. Register-Read Example



#### 9.5.4 Streaming Examples

#### 9.5.4.1 Normal Streaming Example

This example shows how to write six data bytes starting at ADDR 0x28 using the Normal Streaming mode. Because the default STRM\_TYPE is the Normal Streaming mode, setting up the SPI\_STREAMCN register can be omitted.

Transaction 1 – URA Setup – necessary only when the previous URA is different than the desired URA.

Instruction Byte 1 (INST1)	Upper Address Byte	e (UAB)
[7:0]	[7:3]	[2:0]
0x10	0x0	0x2

<u>R/WB = Read/Write Address</u> 0x10: Write Address 0x90: Read Address

#### Transaction 2 – Data Access

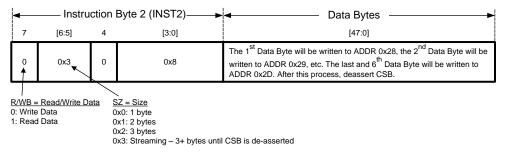


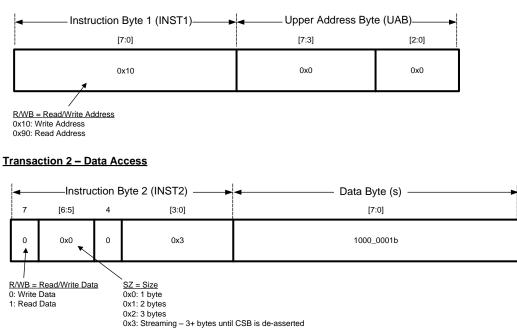
Figure 68. Normal Streaming Example

#### 9.5.4.2 Controlled Streaming Example

This example shows how to read the 16-bit conversion data (ADC\_DOUT) four times using the Controlled Streaming mode. The ADC\_DOUT registers consist of ADC\_DOUTH at ADDR 0x1A and ADC\_DOUTL at ADDR 0x1B.

The first step (Figure 69) sets up the SPI\_STREAMCN register. This step enters the Controlled Streaming mode by setting STRM\_TYPE high in ADDR 0x03. Since two registers (ADDR 0x1A - 0x1B) need to be read, the STRM\_RANGE is 1.

Transaction 1 – URA Setup – necessary only when the previous URA is different than the desired URA.



#### Figure 69. Setting Up SPI\_STREAMCN

The next step shows how to perform the Controlled Streaming mode so that the master device will read ADC\_DOUT from ADDR 0x1A and 0x1B, then wrap back to ADDR 0x1A, and repeat this process for four times. After this process, deassert CSB to end the Controlled Streaming mode.

Transaction 1 – URA Setup – necessary only when the previous URA is different than the desired URA.

Instruction Byte 1 (INST1)	Upper Address Byte	e (UAB)
[7:0]	[7:3]	[2:0]
0x10	0x0	0x1

<u>R/WB = Read/Write Address</u> 0x10: Write Address 0x90: Read Address

#### Transaction 2 – Data Access

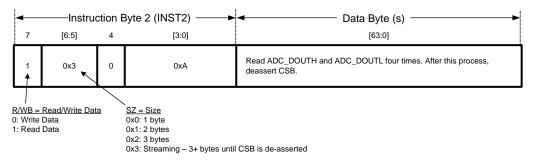


Figure 70. Controlled Streaming Example



# 9.6 Register Maps

- 1. If written to, RESERVED bits must be written to only 0 unless otherwise indicated.
- 2. Read back value of RESERVED bits and registers is unspecified and should be discarded.
- 3. Recommended values must be programmed and forbidden values must not be programmed where they are indicated in order to avoid unexpected results.
- 4. If written to, registers indicated as Reserved must have the indicated default value as shown below. Any other value can cause unexpected results.

REGISTER NAME ADDR (URA & LRA) TYPE DEFAULT				
RESETCN	Reset Control	0x00	WO	-
SPI_HANDSHAKECN	SPI Handshake Control	0x01	R/W	0x00
SPI_RESET SPI Reset Control		0x02	R/W	0x00
SPI_STREAMCN	SPI Stream Control	0x03	R/W	0x00
Reserved	-	0x04 - 0x07	-	0x00
PWRCN	Power Mode Control and Status	0x08	RO & WO	0x00
DATA_ONLY_1	Data Only Read Control 1	0x09	R/W	0x1A
DATA_ONLY_2	Data Only Read Control 2	0x0A	R/W	0x02
ADC_RESTART	ADC Restart Conversion	0x0B	WO	-
Reserved	-	0x0C - 0x0D	-	0x00
GPIO_DIRCN	GPIO Direction Control	0x0E	R/W	0x00
GPIO_DAT	GPIO Data	0x0F	RO & WO	-
BGCALCN	Background Calibration Control	0x10	R/W	0x00
SPI_DRDYBCN	SPI Data Ready Bar Control	0x11	R/W	0x03
ADC_AUXCN	ADC Auxiliary Control	0x12	R/W	0x00
SPI_CRC_CN	CRC Control	0x13	R/W	0x02
SENDIAG_THLD	Sensor Diagnostic Threshold	0x14	R/W	0x00
Reserved	-	0x15-0x16	-	0x0000
SCALCN	System Calibration Control	0x17	R/W	0x00
ADC_DONE	ADC Data Available	0x18	RO	-
SENDIAG_FLAGS	Sensor Diagnostic Flags	0x19	RO	-
ADC_DOUT	Conversion Data 1 and 0	Conversion Data 1 and 0 0x1A - 0x1B RO		-
Reserved	-	0x1C	-	-
SPI_CRC_DAT	CRC Data	0x1D	RO & WO	-
CHANNEL CONFIGURA	TION REGISTERS (CH4 to CH6 for LMP9008	80/LMP90079 only)		
CH_STS	Channel Status	0x1E	RO	0x00
CH_SCAN	Channel Scan Mode	0x1F	R/W	0x30
CH0_INPUTCN	CH0 Input Control	0x20	R/W	0x01
CH0_CONFIG	CH0 Configuration	0x21	R/W	0x70
CH1_INPUTCN	CH1 Input Control	0X22	R/W	0x13
CH1_CONFIG	CH1 Configuration	0x23	R/W	0x70
CH2_INPUTCN	CH2 Input Control	0x24	R/W	0x25
CH2_CONFIG	CH2 Configuration	0x25	R/W	0x70
CH3_INPUTCN	CH3 Input Control	0x26	R/W	0x37
CH3_CONFIG	CH3 Configuration	0x27	R/W	0x70
CH4_INPUTCN	CH4 Input Control	0x28	R/W	0x01
CH4_CONFIG	CH4 Configuration	0x29	R/W	0x70
CH5_INPUTCN	CH5 Input Control	0x2A	R/W	0x13
CH5_CONFIG	CH5 Configuration	0x2B	R/W	0x70
CH6_INPUTCN	CH6 Input Control	0x2C	R/W	0x25

#### Table 7. Register Map

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# **Register Maps (continued)**

	REGISTER NAME	ADDR (URA & LRA)	TYPE	DEFAULT
CH6_CONFIG	CH6 Configuration	0x2D	R/W	0x70
Reserved	-	0x2E - 0x2F	-	0x00
SYSTEM CALIBRATION RE	EGISTERS			
CH0_SCAL_OFFSET	CH0 System Calibration Offset Coefficients	0x30 - 0x31	R/W	0x0000
Reserved	-	0x32	-	0x00
CH0_SCAL_GAIN	CH0 System Calibration Gain Coefficients	0x33 - 0x34	R/W	0x8000
Reserved	-	0x35	-	0x00
CH0_SCAL_SCALING	CH0 System Calibration Scaling Coefficients	0x36	R/W	0x01
CH0_SCAL_BITS_ SELECTOR	CH0 System Calibration Bit Selector	0x37	R/W	0x00
CH1_SCAL_OFFSET	CH1 System Calibration Offset Coefficients	0x38 - 0x39	R/W	0x0000
Reserved	-	0x3A	-	0x00
CH1_SCAL_GAIN	CH1 System Calibration Gain Coefficient	0x3B - 0x3C	R/W	0x8000
Reserved	-	0x3D	-	0x00
CH1_SCAL_SCALING	CH1 System Calibration Scaling Coefficients	0x3E	R/W	0x01
CH1_SCAL_BITS_SELECT OR	CH1 System Calibration Bit Selector	0x3F	R/W	0x00
CH2_SCAL_OFFSET	CH2 System Calibration Offset Coefficients	0x40 - 0x41	R/W	0x0000
Reserved	-	0x42	-	0x00
CH2_SCAL_GAIN	CH2 System Calibration Gain Coefficient	0x43 - 0x44	R/W	0x8000
Reserved	-	0x45	-	0x00
CH2_SCAL_SCALING	CH2 System Calibration Scaling Coefficients	0x46	R/W	0x01
CH2_SCAL_BITS_ SELECTOR	CH2 System Calibration Bit Selector	0x47	R/W	0x00
CH3_SCAL_OFFSET	CH3 System Calibration Offset Coefficients	0x48 - 0x49	R/W	0x0000
Reserved	-	0x4A	-	0x00
CH3_SCAL_GAIN	CH3 System Calibration Gain Coefficient	0x4B - 0x4C	R/W	0x8000
Reserved	-	0x4D	-	0x00
CH3_SCAL_SCALING	CH3 System Calibration Scaling Coefficients	0x4E	R/W	0x01
CH3_SCAL_BITS_ SELECTOR	CH3 System Calibration Bit Selector	0x4F	R/W	0x00
Reserved	-	0x50 - 0x7F	-	0x00

#### Table 7. Register Map (continued)

#### 9.6.1 Power and Reset Registers

#### Table 8. RESTCN

	RESET CONTROL (ADDRESS 0x00)		
BIT	IT BIT SYMBOL BIT DESCRIPTION		
[7:0]	REG_AND_CNV_RST	Register and Conversion Reset <b>0xC3:</b> Register and conversion reset <b>Others:</b> Neglected	



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#### Table 9. SPI\_RESET

	SPI RESET CONTROL (ADDRESS 0x02)		
BIT	BIT SYMBOL	BIT DESCRIPTION	
		SPI Reset Enable	
[0]	SPI_RST	0x0 (default): SPI Reset Disabled	
		0x1: SPI Reset Enabled <sup>(1)</sup>	

#### Table 10. PWRCN

	POWER MODE CONTROL AND STATUS (ADDRESS 0x08)			
BIT	BIT SYMBOL	BIT DESCRIPTION		
[7:2]	Reserved	-		
		Power Control		
		Write Only – power down mode control		
		0x0: Active Mode		
		0x1: Power-down Mode		
[1:0]	PWRCN	0x3: Stand-by Mode		
		Read Only – the present mode is:		
		0x0 (default): Active Mode		
		0x1: Power-down Mode		
		0x3: Stand-by Mode		

(1) Once written, the contents of this register are sticky. That is, the content of this register cannot be changed with subsequent write. However, a Register reset clears the register as well as the sticky status.

#### 9.6.2 ADC Registers

#### Table 11. ADC\_RESTART

	ADC RESTART CONVERSION (ADDRESS 0x0B)		
BIT	BIT SYMBOL	BIT DESCRIPTION	
[7:1]	Reserved	-	
0		Restart conversion	
0 RESTART	RESTART	1: Restart conversion.	

#### Table 12. ADC\_AUXCN

	ADC AUXILIARY CONTROL (ADDRESS 0x12)			
BIT	BIT SYMBOL	BIT DESCRIPTION		
7	Reserved	-		
		The System Calibration registers (CHx_SCAL_OFFSET and CHx_SCAL_GAIN) are:		
6	RESET_SYSCAL	0 (default): preserved even when "REG_AND_CNV_RST" = 0xC3.		
		1: reset by setting "REG_AND_CNV_RST" = 0xC3.		
		External clock detection		
5	CLK_EXT_DET	0 (default): "External Clock Detection" is operational		
		1: "External-Clock Detection" is bypassed		
		Clock select – only valid if CLK_EXT_DET = 1		
4	CLK_SEL	0 (default): Selects internal clock		
		1: Selects external clock		



### Table 12. ADC\_AUXCN (continued)

	ADC AUXILIARY CONTROL (ADDRESS 0x12)			
BIT	BIT SYMBOL	BIT DESCRIPTION		
		Selects RTD Current as follows:		
		<b>0x0 (default):</b> 0 μA		
		<b>0x1:</b> 100 μA		
		<b>0x2:</b> 200 μA		
		<b>0x3:</b> 300 μA		
[3:0]	RTD_CUR_SEL (LMP90080	<b>0x4:</b> 400 μA		
[3.0]	and LMP90078 only)	<b>0x5:</b> 500 μA		
		<b>0x6:</b> 600 μA		
		<b>0x7</b> : 700 μA		
		<b>0x8:</b> 800 μA		
		<b>0x9:</b> 900 μA		
		<b>0xA:</b> 1000 μA		

#### Table 13. ADC\_DONE

	ADC DATA AVAILABLE (ADDRESS 0x18)			
BIT	BIT SYMBOL BIT DESCRIPTION			
		Data Available – indicates if new conversion data is available		
[7:0] DT_AVAIL_B <b>0x00 - 0xFE:</b> Available	0x00 - 0xFE: Available			
	0xFF: Not available			

# Table 14. ADC\_DOUT <sup>(1)</sup>

16-BIT CONVERSION DATA (TWO'S COMPLEMENT) (ADDRESS 0x1A - 0x1B)						
ADDRESS	ADDRESS NAME REGISTER DESCRIPTION					
0x1A	ADC_DOUTH	ADC Conversion Data [15:8]				
0x1B	ADC_DOUTL ADC Conversion Data [7:0]					
0x1C	Reserved	Reserved				

(1) Repeat reads of these registers are allowed as long as such reads are spaced apart by at least 72 µs.

#### 9.6.3 Channel Configuration Registers

### Table 15. CH\_STS

	CHANNEL STATUS (ADDRESS 0x1E)			
BIT	BIT SYMBOL BIT DESCRIPTION			
[7:2]	[7:2] Reserved -			
		Channel Scan Not Ready – indicates if it is okay to program CH_SCAN		
1	CH_SCAN_NRDY	0: Update not pending, CH_SCAN register is okay to program		
		1: Update pending, CH_SCAN register is not ready to be programmed		
		Invalid or Repeated Read Status		
0	INV_OR_RPT_RD_STS	0: ADC_DOUT just read was valid and hitherto unread		
		1: ADC_DOUT just read was either invalid (not ready) or there was a repeated read.		



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#### Table 16. CH\_SCAN <sup>(1)</sup>

	CHANNEL SCAN MODE (ADDRESS 0x1F)			
BIT	BIT SYMBOL	BIT DESCRIPTION		
		Channel Scan Select		
		0x0 (default): ScanMode0: Single-Channel Continuous Conversion		
[7:6]	CH_SCAN_SEL	0x1: ScanMode1: One or more channels Single Scan		
		0x2: ScanMode2: One or more channels Continuous Scan		
		0x3: ScanMode3: One or more channels Continuous Scan with Burnout Currents		
		Last channel for conversion		
		<b>0x0:</b> CH0		
	LAST_CH (CH4 to CH6 for LMP90080 and LMP90079 only)	<b>0x1:</b> CH1		
[5:3]		0x2: CH2		
[5.5]		0x3: CH3		
		<b>0x4:</b> CH4		
		0x5: CH5		
		0x6 (default): CH6 <sup>(2)</sup>		
	FIRST_CH (CH4 to CH6 for LMP90080 and LMP90079 only)	Starting channel for conversion		
		0x0 (default): CH0		
		<b>0x1:</b> CH1		
[2:0]		0x2: CH2		
[2.0]		0x3: CH3		
		<b>0x4:</b> CH4		
		0x5: CH5		
		<b>0x6:</b> CH6 <sup>(3)</sup>		

While writing to the CH\_SCAN register, if 0x7 is written to FIRST\_CH or LAST\_CH the write to the entire CH\_SCAN register is ignored.
 LAST\_CH cannot be smaller than FIRST\_CH. For example, if LAST\_CH = CH5, then FIRST\_CH cannot be CH6. If 0x7 is written it is ignored.

(3) FIRST\_CH cannot be greater than LAST\_CH. For example, if FIRST\_CH = CH1, then LAST\_CH cannot be CH0. If 0x7 is written it is ignored.

#### Table 17. CHx\_INPUTCN

	CHANNEL INPUT CONTROL (CH4 TO CH6 FOR LMP90080/LMP90079 ONLY)				
	REGISTER ADDRESS (HEX): CH0: 0x20, CH1: 0x22, CH2: 0x24, CH3: 0x26, CH4: 0x28, CH5: 0x2A, CH6: 0x2C				
BIT	BIT SYMBOL	MBOL BIT DESCRIPTION			
		Enable sensor diagnostic			
7	BURNOUT_EN	0 (default): Disable Sensor Diagnostics current injection for this Channel			
		1: Enable Sensor Diagnostics current injection for this Channel			
		Select the reference			
6	VREF_SEL	0 (Default): Select VREFP1 and VREFN1			
		1: Select VREFP2 and VREFN2			
		Positive input select			
		0x0: VINO			
		0x1: VIN1			
		0x2: VIN2			
[5:3]	VINP	0x3: VIN3 (LMP90080/LMP90079 only)			
		0x4:VIN4 (LMP90080/LMP90079 only)			
		0x5:VIN5 (LMP90080/LMP90079 only)			
		0x6: VIN6			
		0x7: VIN7 <sup>(1)</sup>			

(1) To see the default values for each channel, refer to the table below.



### Table 17. CHx\_INPUTCN (continued)

	CHANNEL INPUT CONTROL (CH4 TO CH6 FOR LMP90080/LMP90079 ONLY)				
	REGISTER ADDRESS (HEX): CH0: 0x20, CH1: 0x22, CH2: 0x24, CH3: 0x26, CH4: 0x28, CH5: 0x2A, CH6: 0x2C				
BIT	BIT SYMBOL BIT DESCRIPTION				
		Negative input select			
		0x0: VIN0			
		0x1: VIN1			
		0x2: VIN2			
[2:0]	VINN	0x3: VIN3 (LMP90080/LMP90079 only)			
		0x4:VIN4 (LMP90080/LMP90079 only)			
		0x5:VIN5 (LMP90080/LMP90079 only)			
		0x6: VIN6			
		<b>0x7:</b> VIN7 <sup>(1)</sup>			

#### Table 18. Default VIN for CH0-CH6

	VINP	VINN
СНО	VINO	VIN1
CH1	VIN2	VIN3 (LMP90080/LMP90079 only)
CH2	VIN4 (LMP90080/LMP90079 only)	VIN5 (LMP90080/LMP90079 only)
СНЗ	VIN6	VIN7
CH4 (LMP90080/LMP90079 only)	VINO	VIN1
CH5 (LMP90080/LMP90079 only)	VIN2	VIN3
CH6 (LMP90080/LMP90079 only)	VIN4	VIN5

#### Table 19. CHx\_CONFIG

	CHANNEL CONFIGURATION (CH4 TO CH6 LMP90080/LMP90079 ONLY)				
	REGISTER ADDRESS (HEX): CH0: 0x21, CH1: 0x23, CH2: 0x25, CH3: 0x27, CH4: 0x29, CH5: 0x2B, CH6: 0x2D				
BIT	BIT SYMBOL BIT DESCRIPTION				
7	Reserved	-			
		ODR Select			
		<b>0x0:</b> 13.42 / 8 = 1.6775 SPS			
		<b>0x1:</b> 13.42 / 4 = 3.355 SPS			
		<b>0x2:</b> 13.42 / 2 = 6.71 SPS			
[6:4]	ODR_SEL	<b>0x3:</b> 13.42 SPS			
		<b>0x4:</b> 214.65 / 8 = 26.83125 SPS			
		<b>0x5:</b> 214.65 / 4 = 53.6625 SPS			
		<b>0x6:</b> 214.65 / 2 = 107.325 SPS			
		0x7(default): 214.65 SPS			
		Gain Select			
	GAIN_SEL	0x0 (default): 1 (FGA OFF)			
		0x1: 2 (FGA OFF)			
		0x2: 4 (FGA OFF)			
[3:1]		0x3: 8 (FGA OFF)			
		<b>0x4:</b> 16 (FGA ON)			
		<b>0x5:</b> 32 (FGA ON)			
		<b>0x6:</b> 64 (FGA ON)			
		0x7: 128 (FGA ON)			
		Enable/Disable the buffer			
0	BUF_EN	0 (default): Exclude the buffer in the signal path			
		1: Include the buffer from the signal path <sup>(1)</sup>			

(1) When gain  $\geq$  16, the buffer is automatically included in the signal path irrespective of this bit.



#### 9.6.4 Calibration Registers

#### Table 20. BGCALCN

	BACKGROUND CALIBRATION CONTROL (ADDRESS 0x10)			
BIT	BIT BIT SYMBOL BIT DESCRIPTION			
[7:2]	7:2] Reserved -			
		Background calibration control – selects scheme for continuous background calibration.		
	BGCALN	0x0 (default): BgcalMode0: Background Calibration OFF		
[1:0]		0x1: BgcalMode1: Offset Correction / Gain Estimation		
		0x2: BgcalMode2: Offset Correction / Gain Correction		
		0x3: BgcalMode3: Offset Estimation / Gain Estimation		

#### Table 21. SCALCN

	SYSTEM CALIBRATION CONTROL (ADDRESS 0x17)			
BIT BIT SYMBOL BIT DESCRIPTION		BIT DESCRIPTION		
[7:2]	Reserved	-		
		System Calibration Control		
		When written, set SCALCN to:		
		0x0 (default): Normal Mode		
	0x1: "System Calibration Offset Coefficient Determination" mode			
		0x2: "System Calibration Gain Coefficient Determination" mode		
[1:0]       SCALCN <b>0x3:</b> Reserved         When read, this bit indicates the system calibration mode is in: <b>0x0:</b> Normal Mode <b>0x1:</b> "System Calibration Offset Coefficient Determination" mode		0x3: Reserved		
		When read, this bit indicates the system calibration mode is in:		
		0x0: Normal Mode		
		0x1: "System Calibration Offset Coefficient Determination" mode		
		0x2: "System Calibration Gain Coefficient Determination" mode		
		0x3: Reserved <sup>(1)</sup>		

(1) When read, this bit will indicate the current System Calibration status. Since this coefficient determination mode will only take 1 conversion cycle, reading this register will only return 0x00, unless this register is read within 1 conversion window.

## Table 22. CHx\_SCAL\_OFFSET

	CH0-CH3 SYSTEM CALIBRATION OFFSET REGISTERS (TWO'S-COMPLEMENT)					
ADDR				NAME	DESCRIPTION	
CH0	CH1	CH2	СНЗ	NAME	DESCRIPTION	
0x30	0x38	0x40	0x48	CHx_SCAL_OFFSETH	System Calibration Offset Coefficient Data [15:8]	
0x31	0x39	0x41	0x49	CHx_SCAL_OFFSETM	System Calibration Offset Coefficient Data [7:0]	
0x32	0x3A	0x42	0x4A	Reserved	-	

#### Table 23. CHx\_SCAL\_GAIN

	CH0-CH3 SYSTEM CALIBRATION GAIN REGISTERS (FIXED POINT 1.23 FORMAT)					
	ADDR					
CH0	CH1	CH2	СНЗ	NAME	DESCRIPTION	
0x33	0x3B	0x43	0x4B	CHx_SCAL_GAINH	System Calibration Gain Coefficient Data [15:8]	
0x34	0x3C	0x44	0x4C	CHx_SCAL_GAINL	System Calibration Gain Coefficient Data [7:0]	
0x35	x35 0x3D 0x45 0x4D Reserved -					

#### Table 24. CHx\_SCAL\_SCALING

	CH0-CH3 SYSTEM CALIBRATION SCALING COEFFICIENT REGISTERS					
	ADDR CH0 CH1 CH2 CH3				DESCRIPTION	
CH0			СНЗ	NAME		
0x36	0x3E	0x46	0x4E	CHx_SCAL_SCALING	System Calibration Scaling Coefficient Data [5:0]	

#### Table 25. CHx\_SCAL\_BITS\_SELECTOR

	CH0-CH3 SYSTEM CALIBRATION BIT SELECTOR REGISTERS				
	ADDR			NAME	DESCRIPTION
CH0	CH1	CH2	CH3	NAME	DESCRIPTION
0x37	0x3F	0x47	0x4F	CHx_SCAL_BITS_SELECTOR	System Calibration Bit Selection Data [2:0]

### 9.6.5 Sensor Diagnostic Registers

#### Table 26. SENDIAG\_THLD

	SENS	OR DIAGNOSTIC THRESHOLD (ADDRESS 0x14)
ADDRESS	NAME	REGISTER DESCRIPTION
0x14	SENDIAG_THLD	Sensor Diagnostic threshold

#### Table 27. SENDIAG\_FLAGS

		SENSOR DIAGNOSTIC FLAGS (ADDRESS 0x19)
BIT	BIT SYMBOL	BIT DESCRIPTION
7	SHORT_THLD_ FLAG	Short Circuit Threshold Flag = 1 when the absolute value of VOUT is within the absolute threshold voltage set by the SENDIAG_THLD register.
6	RAILS_FLAG	Rails Flag = 1 when at least one of the inputs is near rail (VA or GND).
5	POR_AFT_LST_RD	Power-on-reset after last read = 1 when there was a power-on-reset event since the last time the SENDIAG_FLAGS register was read.
		Overflow flags
		0x0: Normal operation
[4:3]	OFLO_FLAGS	<b>0x1:</b> The modulator was not over-ranged, but ADC_DOUT got clamped to 0x7f_ffff (positive fullscale) or 0x80_0000 (negative full scale)
		0x2: The modulator was over-ranged (VIN > 1.2*VREF/GAIN)
		0x3: The modulator was over-ranged (VIN < -1.2*VREF/GAIN)
[2:0]	SAMPLED_CH	Channel Number – the sampled channel for ADC_DOUT and SENDIAG_FLAGS.

### 9.6.6 SPI Registers

#### Table 28. SPI\_HANDSHAKECN

		SPI HANDSH	AKE CONTROL (ADDRESS	6 0x01)	
BIT	BIT SYMBOL	BIT DESCRIPTIO	DN .		
[7:4]	Reserved	-			
		SDO/DRDYB Driv	ver – sets who is driving the S	DO/DRDYB pin	
[2:4]	SDO_DRDYB_ DRIVER		Whenever CSB is Asserted and the Device is Reading ADC_DOUT	Whenever CSB is Asserted and the Device is Not Reading ADC_DOUT	CSB is Deasserted
[3:1]		0x0 (default)	SDO is driving	DRDYB is driving	High-Z
		0x3	SDO is driving	DRDYB is driving	DRDYB is driving
		0x4	SDO is driving	High-Z	High-Z
		Others	Forbidden		



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# Table 28. SPI\_HANDSHAKECN (continued)

		SPI HANDSHAKE CONTROL (ADDRESS 0x01)
BIT	BIT SYMBOL	BIT DESCRIPTION
0	SW_OFF_TRG	<ul> <li>Switch-off trigger - refers to the switching of the output drive from the slave to the master.</li> <li><b>0 (default):</b> SDO will be high-Z after the last (16th, 24th, 32nd, etc) rising edge of SCLK. This option allows time for the slave to transfer control back to the master at the end of the frame.</li> <li><b>1:</b> SDO's high-Z is postponed to the subsequent falling edge following the last (16th, 24th, 32nd, etc) rising edge of SCLK. This option provides additional hold time for the last bit, DB0, in non-streaming read transfers.</li> </ul>

#### Table 29. SPI\_STREAMCN

	SPI STREAMING CONTROL (ADDRESS 0x03)		
BIT	BIT SYMBOL	BIT DESCRIPTION	
		Stream type	
7	STRM_TYPE	0 (default): Normal Streaming mode	
		1: Controlled Streaming mode	
[6.0]	STRM RANGE	Stream Range – selects Range for Controlled Streaming mode	
[6:0]	STRM_ RANGE	Default: 0x00	

#### Table 30. DATA\_ONLY\_1

	DATA ONLY READ CONTROL 1 (ADDRESS 0x09)			
BIT	BIT SYMBOL	BIT DESCRIPTION		
7	Reserved	-		
		Start address for the Data Only Read Transaction		
[6:0]	DATA_ONLY_ADR	<b>Default:</b> 0x1A Please refer to the description of DT_ONLY_SZ in Table 31 register.		

#### Table 31. DATA\_ONLY\_2

		DATA ONLY READ CONTROL 2 (ADDRESS 0x0A)
BIT	BIT SYMBOL	BIT DESCRIPTION
[7:3]	Reserved	-
[2:0]	DATA_ONLY_SZ	Number of bytes to be read out in Data Only mode. A value of 0x0 means read one byte and 0x7 means read 8 bytes.
		Default: 0x2

#### Table 32. SPI\_DRDYBCN

		SPI DATA READY BAR CONTROL (ADDRESS 0x11)
BIT	BIT SYMBOL	BIT DESCRIPTION
		Enable DRDYB on D6
7	SPI_DRDYB_D6	0 (default): D6 is a GPIO
		1: D6 = DRDYB signal
6	Reserved	-
5	CRC_RST	CRC Reset <b>0 (default):</b> Enable CRC reset on DRDYB deassertion <b>1:</b> Disable CRC reset on DRDYB deassertion
4	Reserved	-
		Gain background calibration
3	FGA_BGCAL	<b>0</b> (default): Correct FGA gain error. This is useful only if the device is operating in BgcalMode2 and ScanMode2 or ScanMode3.
		1: Correct FGA gain error using the last known coefficients.
[2:0]	Reserved	Default - 0x3 (do not change this value)

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### Table 33. SPI\_CRC\_CN

	CRC CONTROL (ADDRESS 0x13)							
BIT	BIT SYMBOL	BIT DESCRIPTION						
[7:5]	Reserved	-						
		Enable CRC						
4	EN_CRC	0 (default): Disable CRC						
		1: Enable CRC						
3	Reserved	Default - 0x0 (do not change this value)						
		DRDYB After CRC						
2	DRDYB_AFT_CRC	0 (default): DRDYB is deasserted (active high) after ADC_DOUTL is read.						
		1: DRDYB is deasserted after SPI_CRC_DAT (which follows ADC_DOUTL), is read.						
[1:0]	Reserved	-						

# Table 34. SPI\_CRC\_DAT

	CRC DATA (ADDRESS 0x1D)							
BIT	BIT SYMBOL BIT DESCRIPTION							
	CRC_DAT	CRC Data						
[7:0]		When written, this register reset CRC:						
[7.0]		Any Value: Reset CRC						
		When read, this register indicates the CRC data.						

#### 9.6.7 GPIO Registers

# Table 35. GPIO\_DIRCN

	GPIO DIRECTION (ADDRESS 0x0E)								
BIT	BIT SYMBOL	BIT DESCRIPTION							
7	Reserved	-							
		GPIO direction control – these bits are used to control the direction of each General Purpose Input/Outputs (GPIO) pins D0 - D6.							
		0 (default): Dx is an Input							
х	GPIO_DIRCNx	1: Dx is an Output							
		where $0 \le x \le 6$							
		For example, writing a 1 to bit 6 means D6 is an Output. <sup>(1)</sup>							

(1) If D6 is used for DRDYB, then it cannot be used for GPIO.

#### Table 36. GPIO\_DAT

	GPIO DATA (ADDRESS 0x0F)								
BIT	BIT SYMBOL	BIT DESCRIPTION							
7	Reserved	-							
		Write Only - when GPIO_DIRCNx = 0							
		0: Dx is LO							
		1: Dx is HI Read Only - when GPIO_DIRCNx = 1							
		0: Dx driven LO							
x	Dx	1: Dx driven HI							
		where $0 \le x \le 6$							
		For example, writing a 0 to bit 4 means D4 is LO.							
		It is okay to Read the GPIOs that are configured as outputs and write to GPIOs that are configured as inputs. Reading the GPIOs that are outputs would return the current value on those GPIOs, and writing to the GPIOs that are inputs are neglected.							



### **10** Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### **10.1** Application Information

#### **10.1.1 Connecting the Supplies**

#### **10.1.1.1** $V_A$ and $V_{IO}$

Any ADC architecture is sensitive to spikes on the analog voltage,  $V_A$ , digital input/output voltage,  $V_{IO}$ , and ground pins. These spikes may originate from switching power supplies, digital logic, high power devices, and other sources. To diminish these spikes, the LMP900xx's  $V_A$  and  $V_{IO}$  pins should be clean and well bypassed. A 0.1  $\mu$ F ceramic bypass capacitor and a 1  $\mu$ F tantalum capacitor should be used to bypass the LMP900xx supplies, with the 0.1  $\mu$ F capacitor placed as close to the LMP900xx as possible.

Since the LMP900xx has both external  $V_A$  and  $V_{IO}$  pins, the user has two options on how to connect these pins. The first option is to tie  $V_A$  and  $V_{IO}$  together and power them with the same power supply. This is the most cost effective way of powering the LMP900xx but is also the least ideal because noise from  $V_{IO}$  can couple into  $V_A$  and negatively affect performance. The second option involves powering  $V_A$  and  $V_{IO}$  with separate power supplies. These supply voltages can have the same amplitude or they can be different.

#### 10.1.1.2 V<sub>REF</sub>

Operation with V<sub>REF</sub> below V<sub>A</sub> is also possible with slightly diminished performance. As V<sub>REF</sub> is reduced, the range of acceptable analog input voltages is also reduced. Reducing the value of V<sub>REF</sub> also reduces the size of the LSB. When the LSB size goes below the noise floor of the LMP900xx, the noise will span an increasing number of codes and performance will degrade. For optimal performance, V<sub>REF</sub> should be the same as V<sub>A</sub> and sourced with a clean source that is bypassed with a ceramic capacitor value of 0.1  $\mu$ F and a tantalum capacitor of 10  $\mu$ F.

LMP900xx also allows ratiometric connection for noise immunity reasons. A ratiometric connection is when the ADC's  $V_{REFP}$  and  $V_{REFN}$  are used to excite the input device's (i.e. a bridge sensor) voltage references. This type of connection severely attenuates any  $V_{REF}$  ripple seen the ADC output, and is thus strongly recommended.

#### 10.1.2 Quick Start

This section shows step-by-step instructions to configure the LMP900xx to perform a simple DC reading from CH0.

- 1. Apply  $V_A = V_{IO} = V_{REFP1} = 5V$ , and ground  $V_{REFN1}$
- 2. Apply  $V_{INP} = \sqrt[3]{4}V_{REF}$  and  $V_{INN} = \frac{1}{4}V_{REF}$  for CH0. Thus, set CH0 =  $V_{IN} = V_{INP} V_{INN} = \frac{1}{2}V_{REF}$  (CH0\_INPUTCN register)
- 3. Set gain = 1 (CH0\_CONFIG: GAIN\_SEL = 0x0)
- 4. Exclude the buffer from the signal path (CH0\_CONFIG: BUF\_EN = 0)
- 5. Set the background to BgcalMode2 (BGCALCN = 0x2)
- 6. Select  $V_{REF1}$  (CH0\_INPUTCN:  $V_{REF SEL} = 0$ )
- 7. To use the internal CLK, set CLK\_EXT\_DET = 1 and CLK\_SEL = 0.
- 8. Follow the register read/write protocol (Figure 55) to capture ADC\_DOUT from CH0.

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#### **Application Information (continued)**

#### 10.1.3 ADC\_DOUT Calculation

The output code of the LMP900xx can be calculated as:

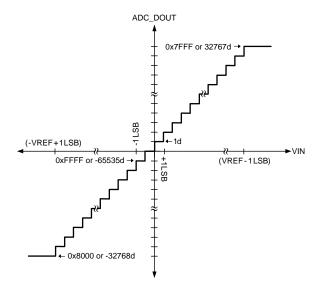
$$ADC\_DOUT = \pm \left(\frac{(VINP - VINN) \times GAIN}{VREFP - VREFN}\right) \times (2^{15})$$

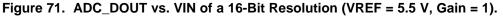
Output Code

(13)

ADC\_DOUT is in 16-bit two's complement binary format. The largest positive value is 0x7FFF (or 32767 in decimal), while the largest negative value is 0x8000 (or 32768 in decimal). In case of an over range the value is automatically clamped to one of these two values.

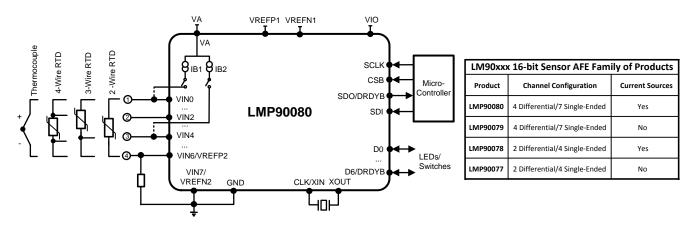
Figure 71 shows the theoretical output code, ADC\_DOUT, vs. analog input voltage,  $V_{IN}$ , using the equation above.





#### **10.2 Typical Applications**









#### **Typical Applications (continued)**

#### 10.2.1.1 Design Requirements

- VA = 3 V
- VIO = 3 V
- 3-Wire RTD using 2 current sources

#### 10.2.1.2 Detailed Design Procedure

Figure 72 shows the first topology for a 3-wire resistive temperature detector (RTD) application. Topology #1 uses two excitation current sources, IB1 and IB2, to create a differential voltage across VIN0 and VIN1. As a result of using both IB1 and IB2, only one channel (VIN0-VIN1) needs to be measured. As shown in Equation 14, the equation for this channel is IB1 x (RTD – RCOMP) assuming that RLINE1 = RLINE2.

 $\begin{array}{l} \mathsf{VIN0} = \mathsf{IB1} \; (\mathsf{RLINE1} + \mathsf{RTD}) + (\mathsf{IB1} + \mathsf{IB2}) \; (\mathsf{RLINE3} + \mathsf{RREF}) \\ \mathsf{VIN1} = \mathsf{IB2} \; (\mathsf{RLINE2} + \mathsf{RCOMP}) + (\mathsf{IB1} + \mathsf{IB2}) \; (\mathsf{RLINE3} + \mathsf{RREF}) \\ \mathsf{If} \; \mathsf{RLINE1} = \mathsf{RLINE2}, \; \mathsf{then:} \\ \mathsf{VIN} = (\mathsf{VIN0} - \mathsf{VIN1}) = \mathsf{IB1} \; (\mathsf{RTD} - \mathsf{RCOMP}) \\ \end{array}$ 

VIN Equation for Topology #1

(14)

The PT-100 changes linearly from 100  $\Omega$  at 0°C to 146.07  $\Omega$  at 120°C. If desired, choose a suitable compensating resistor (RCOMP) so that VIN can be virtually 0 V at any desirable temperature. For example, if RCOMP = 100  $\Omega$ , then at 0°C, VIN = 0 V and thus a higher gain can be used.

The advantage of this circuit is its ratiometric configuration, where  $VREF = (IB1 + IB2) \times (RREF)$ . Equation 15 shows that a ratiometric configuration eliminates IB1 and IB2 from the output equation, thus increasing the overall performance.

 $ADC_DOUT = \frac{VIN(Gain)}{2VREF} (2^{n})$  $ADC_DOUT = \frac{[IB1(RTD - RCOMP)Gain]}{2(IB1 + IB2)RREF} (2^{n})$  $ADC_DOUT = \frac{[(RTD - RCOMP)Gain]}{2(2)RREF} (2^{n})$ 

ADC\_DOUT Showing IB1 & IB2 Elimination

#### 10.2.1.3 Application Curve

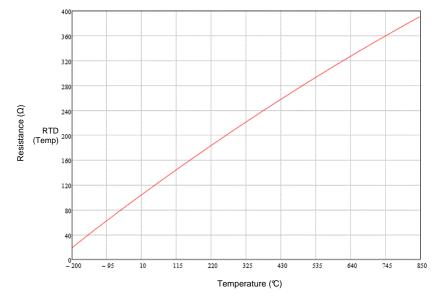


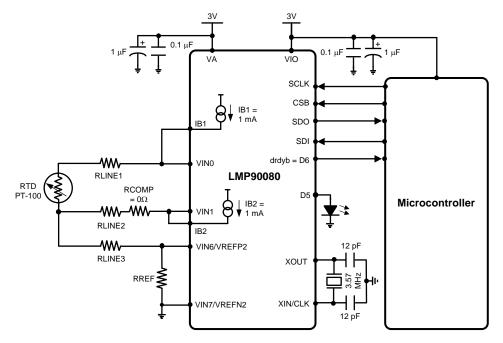
Figure 73. PT-100 RTD Resistance from –200°C to 850°C

(15)



#### **Typical Applications (continued)**

#### 10.2.2 3–Wire RTD





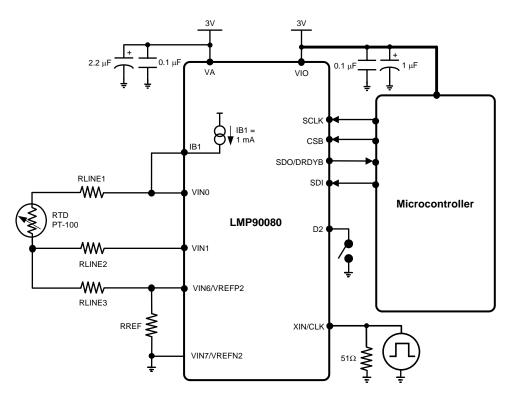


Figure 75. Topology #2: 3-Wire RTD using 1 Current Source



# **Typical Applications (continued)**

#### 10.2.2.1 Design Requirements

- VA = 3V
- VIO = 3V
- 3-Wire RTD using 1 current source

#### 10.2.2.2 Detailed Design Procedure

Figure 75 shows the second topology for a 3-Wire RTD application. Topology #2 shows the same connection as topology #1, but without IB2. Although this topology eliminates a current source, it requires two channel measurements as shown in Equation 16.

VIN0 = IB1 (RLINE1 + RTD + RLINE3 + RREF) VIN1 = IB1 (RLINE3 + RREF) VIN6 = IB1 (RREF)

 $\label{eq:choice} \begin{array}{l} \mathsf{CH0} = \mathsf{VIN0} - \mathsf{VIN1} = \mathsf{IB1} \; (\mathsf{RLINE1} + \mathsf{RTD}) \\ \mathsf{CH1} = \mathsf{VIN1} - \mathsf{VIN6} = \mathsf{IB1} \; (\mathsf{RLINE3}) \end{array}$ 

Assume RLINE1 = RLINE3, thus: CH0 - CH1 = IB1 (RTD)

VIN Equation for Topology #2

#### 10.2.2.3 Application Curve

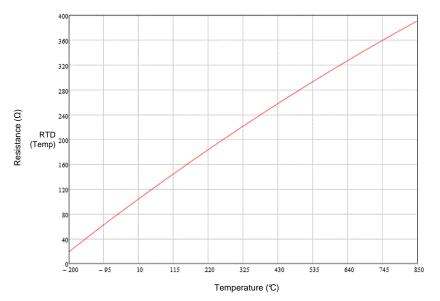


Figure 76. PT-100 RTD Resistance from -200°C to 850°C



### **Typical Applications (continued)**

#### 10.2.3 Thermocouple and IC Analog Temperature

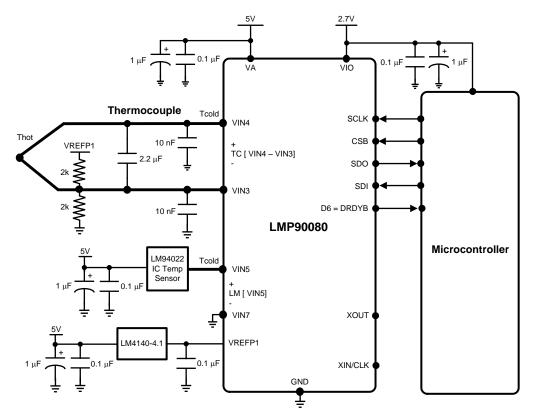


Figure 77. Thermocouple with CJC

#### 10.2.3.1 Design Requirements

- VA = 5V
- VIO = 2.7V
- Thermocouple with Cold Junction Compensation

#### 10.2.3.2 Detailed Design Procedure

The LMP900xx is also ideal for thermocouple temperature applications. Thermocouples have several advantages that make them popular in many industrial and medical applications. Compare to RTDs, thermistors, and IC sensors, thermocouples are the most rugged, least expensive, and can operate over the largest temperature range.

A thermocouple is a sensor whose junction generates a differential voltage, VIN, that is relative to the temperature difference  $(T_{hot} - T_{cold})$ .  $T_{hot}$  is also known as the measuring junction or "hot" junction, which is placed at the measured environment.  $T_{cold}$  is also known as the reference or "cold" junction, which is placed at the measuring system environment.

Because a thermocouple can only measure a temperature difference, it does not have the ability to measure absolute temperature. To determine the absolute temperature of the measured environment ( $T_{hot}$ ), a technique known as cold junction compensation (CJC) must be used.

In a CJC technique, the "cold" junction temperature,  $T_{cold}$ , is sensed by using an IC temperature sensor, such as the LM94022. The temperature sensor should be placed within close proximity of the reference junction and should have an isothermal connection to the board to minimize any potential temperature gradients.



#### **Typical Applications (continued)**

Once  $T_{cold}$  is obtained, use a standard thermocouple look-up-table to find its equivalent voltage. Next, measure the differential thermocouple voltage and add the equivalent cold junction voltage. Lastly, convert the resulting voltage to temperature using a standard thermocouple look-up-table.

For example, assume  $T_{cold} = 20^{\circ}$ C. The equivalent voltage from a type K thermocouple look-up-table is 0.798 mV. Next, add the measured differential thermocouple voltage to the  $T_{cold}$  equivalent voltage. For example, if the thermocouple voltage is 4.096 mV, the total would be 0.798 mV + 4.096 mV = 4.894 mV. Referring to the type K thermocouple table gives a temperature of 119.37°C for 4.894 mV.

#### 10.2.3.3 Application Curve

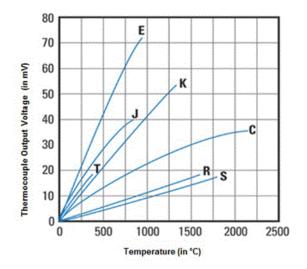


Figure 78. Thermocouple Output as Function of Temperature

## **11 Power Supply Recommendations**

The device can be placed in Active, Power-Down, or Stand-By state.

In Power-Down, the ADC is not converting data, contents of the registers are unaffected, and there is a drastic power reduction. In Stand-By, the ADC is not converting data, but the power is only slightly reduced so that the device can quickly transition into the active state if desired.

These states can be selected using the PWRCN register. When written, PWRCN brings the device into the Active, Power-Down, or Stand-By state. When read, PWRCN indicates the state of the device.

The read value would confirm the write value after a small latency (approximately 15 µs with the internal CLK). It may be appropriate to wait for this latency to confirm the state change. Requests not adhering to this latency requirement may be rejected.

It is not possible to make a direct transition from the power-down state to the stand-by state. This state diagram is shown below.

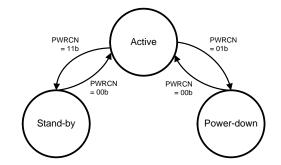


Figure 79. Active, Power-Down, Stand-By State Diagram

# 12 Layout

## 12.1 Layout Guidelines

- Follow the guidelines in the *Power Supply Recommendations* section.
- Keep analog traces away from digital traces.
- Never run an analog and digital trace parallel to each other.
- If a digital and analog trace need to cross each other cross them at a 90° angle.
- Use a solid ground plane under the device.

## 12.2 Layout Example

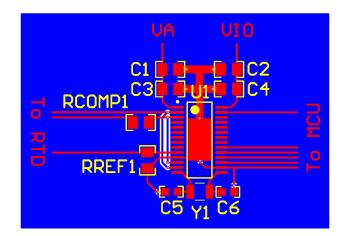


Figure 80. LMP90xx Sample Layout



#### 13 器件和文档支持

13.1 器件支持

13.1.1 器件命名规则

共模抑制比 测量两个输入引脚对于同相共模信号的抑制能力。要计算 CMRR, 需测得共模输入电压变化时的输出 偏移变化。

**CMRR** = 20 LOG (Δ共模输入 / Δ输出偏移)

有效位数量(ENOB 或有效位) – 表示转换器等效于理想 ADC 时的有效位数量 (ENOB)。LMP90080 的 ENOB 是 一项直流 ENOB 规范,而非使用快速傅立叶变换 (FFT) 和信纳比 (SINAD) 测得的动态 ENOB。其计算格式如下:

 $ENOB = \log_2\left(\frac{2 \times VREF/Gain}{RMS Noise}\right)$ 

(17)

(18)

增益误差是与传递函数理想斜率间的偏差。

积分非线性 (INL) 测量通过输入到输出传递函数的直线上每一个代码的偏差。这条直线上的任何给定代码的偏差都 是从代码值的中心测量的。使用的是端点拟合方法。根据电气特性表,该产品的 INL 规定在一个有限范围内。

负满量程误差是输出代码转换到负满量程时的差动输入电压与 (-VREF + 1 LSB) 之差。

负增益误差 是负满量程误差与偏移误差除以 (VREF / 增益) 之差。

无噪声分辨率 是指定转换器噪声位数的一种方法。

$$NFR = \log_2\left(\frac{2 \text{ x VREF/Gain}}{\text{Peak-to-Peak Noise}}\right)$$

ODR 输出数据速率。

偏移误差 是输出代码由 0000h 转换至 0001h 的差分输入电压与 1 LSB 之差。

正满量程误差是输出代码转换至正满量程时的差动输入电压与 (VREF - 1 LSB) 之差。

正增益误差 是正满量程误差与偏移误差除以 (VREF / 增益) 之差。

电源抑制比 (PSRR) 测量对模拟电源电压变化的抑制能力。PSRR 计算的是给定电源电压变化量的偏移误差变化 比,单位为 dB。

**PSRR** = 20 LOG (ΔVA / Δ输出偏移)

#### 13.2 相关链接

以下表格列出了快速访问链接。范围包括技术文档、支持与社区资源、工具和软件,并且可以快速访问样片或购买 链接。

器件	产品文件夹	样片与购买	技术文章	工具与软件	支持与社区
LMP90077	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
LMP90078	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
LMP90079	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
LMP90080	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处

#### 表 37. 相关链接

#### 13.3 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

# TI E2E<sup>™</sup> Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.



### 社区资源(接下页)

**Design Support TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 13.4 商标

E2E is a trademark of Texas Instruments. WEBENCH is a registered trademark of Texas Instruments. All other trademarks are the property of their respective owners.

### 13.5 静电放电警告

这些装置包含有限的内置 ESD 保护。存储或装卸时,应将导线一起截短或将装置放置于导电泡棉中,以防止 MOS 门极遭受静电损伤。

### 13.6 Glossary

#### SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 14 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对 本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本,请查阅左侧的导航栏。



10-Dec-2020

# **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
LMP90077MH/NOPB	ACTIVE	HTSSOP	PWP	28	48	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90077 MH	Samples
LMP90077MHE/NOPB	ACTIVE	HTSSOP	PWP	28	250	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90077 MH	Samples
LMP90077MHX/NOPB	ACTIVE	HTSSOP	PWP	28	2500	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90077 MH	Samples
LMP90078MH/NOPB	ACTIVE	HTSSOP	PWP	28	48	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90078 MH	Samples
LMP90078MHE/NOPB	ACTIVE	HTSSOP	PWP	28	250	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90078 MH	Samples
LMP90078MHX/NOPB	ACTIVE	HTSSOP	PWP	28	2500	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90078 MH	Samples
LMP90079MH/NOPB	ACTIVE	HTSSOP	PWP	28	48	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90079 MH	Samples
LMP90079MHE/NOPB	ACTIVE	HTSSOP	PWP	28	250	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90079 MH	Samples
LMP90079MHX/NOPB	ACTIVE	HTSSOP	PWP	28	2500	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90079 MH	Samples
LMP90080MH/NOPB	ACTIVE	HTSSOP	PWP	28	48	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90080 MH	Samples
LMP90080MHE/NOPB	ACTIVE	HTSSOP	PWP	28	250	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90080 MH	Samples
LMP90080MHX/NOPB	ACTIVE	HTSSOP	PWP	28	2500	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	LMP90080 MH	Samples

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".



# PACKAGE OPTION ADDENDUM

10-Dec-2020

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption. **Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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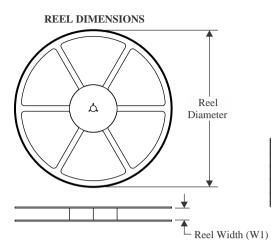
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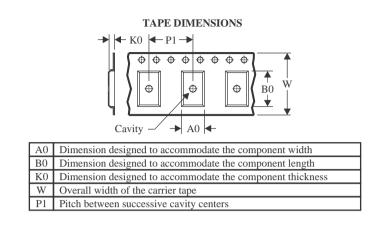
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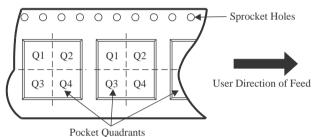
STRUMENTS

### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



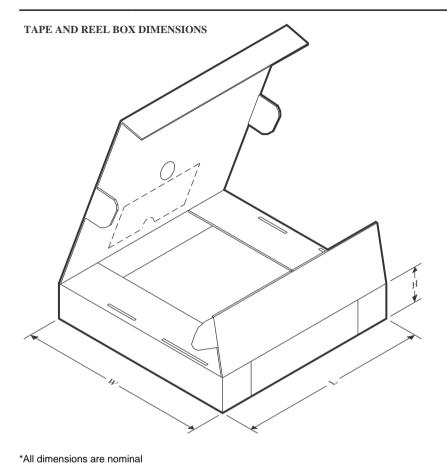
*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMP90077MHE/NOPB	HTSSOP	PWP	28	250	178.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1
LMP90077MHX/NOPB	HTSSOP	PWP	28	2500	330.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1
LMP90078MHE/NOPB	HTSSOP	PWP	28	250	178.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1
LMP90078MHX/NOPB	HTSSOP	PWP	28	2500	330.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1
LMP90079MHE/NOPB	HTSSOP	PWP	28	250	178.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1
LMP90079MHX/NOPB	HTSSOP	PWP	28	2500	330.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1
LMP90080MHE/NOPB	HTSSOP	PWP	28	250	178.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1
LMP90080MHX/NOPB	HTSSOP	PWP	28	2500	330.0	16.4	6.8	10.2	1.6	8.0	16.0	Q1



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# PACKAGE MATERIALS INFORMATION

9-Aug-2022



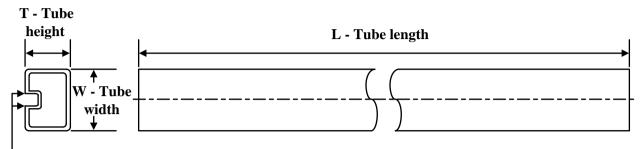
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMP90077MHE/NOPB	HTSSOP	PWP	28	250	208.0	191.0	35.0
LMP90077MHX/NOPB	HTSSOP	PWP	28	2500	356.0	356.0	35.0
LMP90078MHE/NOPB	HTSSOP	PWP	28	250	208.0	191.0	35.0
LMP90078MHX/NOPB	HTSSOP	PWP	28	2500	356.0	356.0	35.0
LMP90079MHE/NOPB	HTSSOP	PWP	28	250	208.0	191.0	35.0
LMP90079MHX/NOPB	HTSSOP	PWP	28	2500	356.0	356.0	35.0
LMP90080MHE/NOPB	HTSSOP	PWP	28	250	208.0	191.0	35.0
LMP90080MHX/NOPB	HTSSOP	PWP	28	2500	356.0	356.0	35.0

# TEXAS INSTRUMENTS

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9-Aug-2022

# TUBE



# - B - Alignment groove width

#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
LMP90077MH/NOPB	PWP	HTSSOP	28	48	495	8	2514.6	4.06
LMP90078MH/NOPB	PWP	HTSSOP	28	48	495	8	2514.6	4.06
LMP90079MH/NOPB	PWP	HTSSOP	28	48	495	8	2514.6	4.06
LMP90080MH/NOPB	PWP	HTSSOP	28	48	495	8	2514.6	4.06

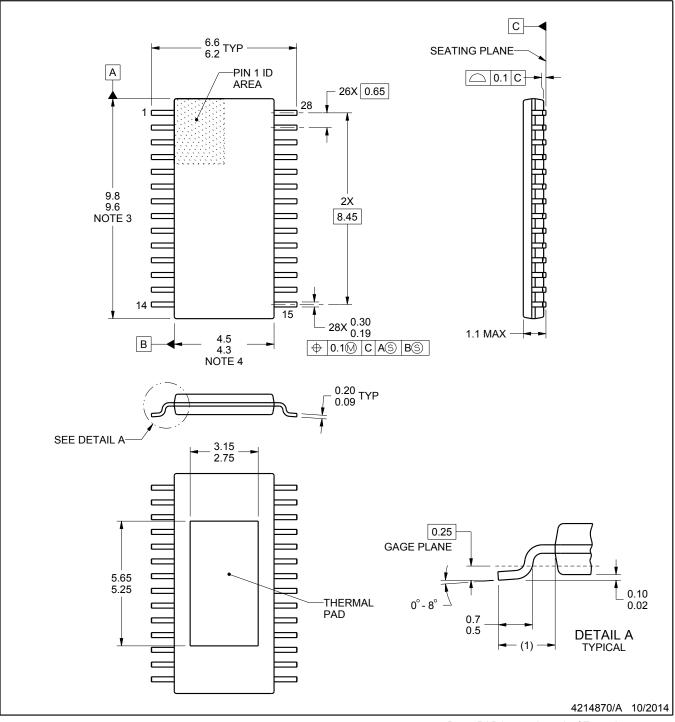
# **PWP0028A**



# **PACKAGE OUTLINE**

PowerPAD<sup>™</sup> - 1.1 mm max height

PLASTIC SMALL OUTLINE



NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MO-153, variation AET.

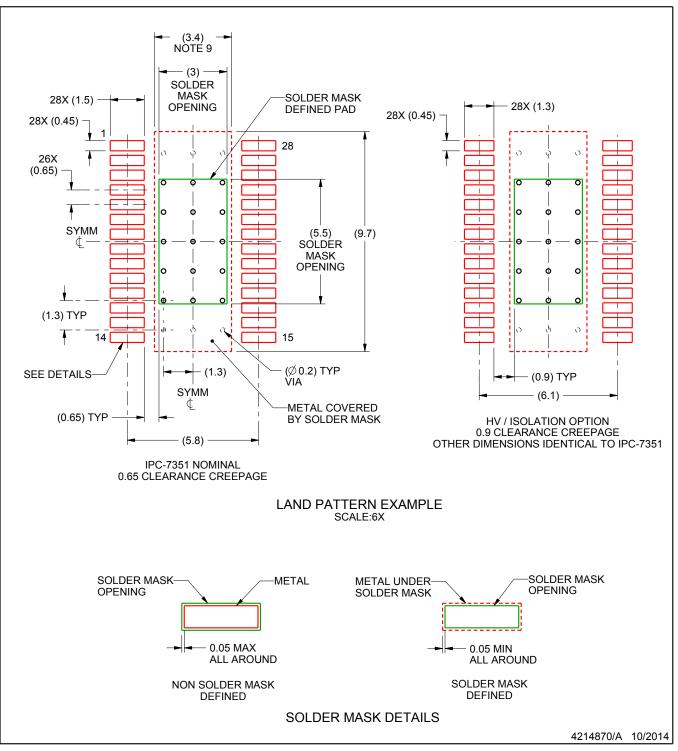


# **PWP0028A**

# **EXAMPLE BOARD LAYOUT**

# PowerPAD<sup>™</sup> - 1.1 mm max height

PLASTIC SMALL OUTLINE



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).
- 9. Size of metal pad may vary due to creepage requirement.

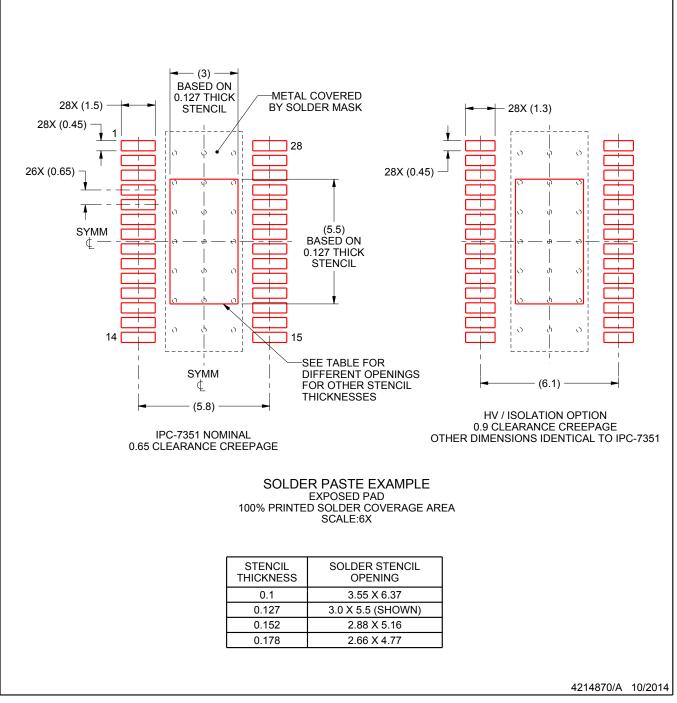


# **PWP0028A**

# **EXAMPLE STENCIL DESIGN**

# PowerPAD<sup>™</sup> - 1.1 mm max height

PLASTIC SMALL OUTLINE



NOTES: (continued)

10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

11. Board assembly site may have different recommendations for stencil design.



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